



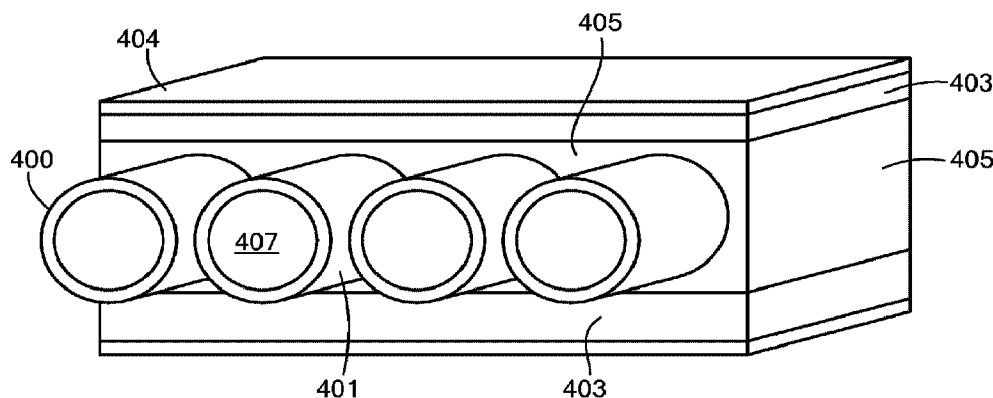
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(57) Abrégé/Abstract:

A detector and methods for inspecting material on the basis of scintillator coupled by wavelength-shifting optical fiber to one or more photo-detectors, with a temporal integration of the photo-detector signal. An unpixelated volume of scintillation medium



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converts energy of incident penetrating radiation into scintillation light which is extracted from a scintillation light extraction region by a plurality of optical waveguides. This geometry provides for efficient and compact detectors, enabling hitherto unattainable geometries for backscatter detection and for energy discrimination of incident radiation. Additional energy-resolving transmission configurations are enabled as are skew- and misalignment compensation.

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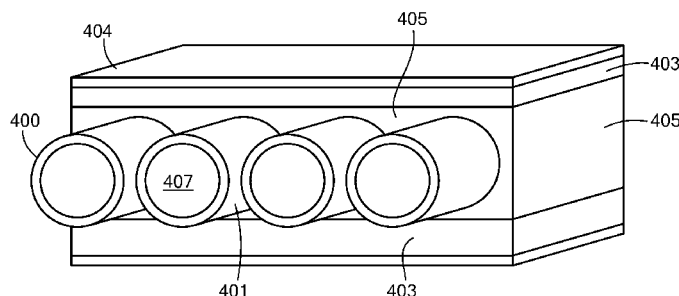


FIG. 4

(57) Abstract: A detector and methods for inspecting material on the basis of scintillator coupled by wavelength-shifting optical fiber to one or more photo-detectors, with a temporal integration of the photo-detector signal. An unpixelated volume of scintillation medium converts energy of incident penetrating radiation into scintillation light which is extracted from a scintillation light extraction region by a plurality of optical waveguides. This geometry provides for efficient and compact detectors, enabling hitherto unattainable geometries for backscatter detection and for energy discrimination of incident radiation. Additional energy-resolving transmission configurations are enabled as are skew- and misalignment compensation.



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X-Ray Inspection using Wavelength-Shifting Fiber-Coupled Scintillation Detectors

[0001] The present application claims priority from US Provisional Patent Applications, Serial Nos. 61/598,521, and 61/598,576, both filed February 14, 2012, and US Provisional Patent Applications, Serial No. 61/607,066, filed March 6, 2012.

Technical Field

[0002] The present invention relates to fiber-coupled scintillation detectors and to methods of their manufacture, and to systems and methods of x-ray inspection employing fiber-coupled scintillation detectors for efficient detection of x-rays.

Background Art

[0003] Fiber-coupled scintillation detectors of radiation and particles have been employed over the course of the past 30 years. In some cases, the scintillator is pixelated, consisting of discrete scintillator elements, and in other cases, other stratagems are employed (such as orthogonally crossed coupling fibers) in order to provide spatial resolution. Examples of fiber-coupled scintillation detectors are provided by US Patent Nos. 6,078,052 (to DiFilippo) and 7,326,9933 (to Katagiri *et al.*).

Detectors described both by DiFilippo and Katagiri *et al.* employ wavelength-shifting fibers (WSF) such that light reemitted by the core material of the fiber may be conducted, with low attenuation, to photo-detectors disposed at a convenient location, often distant from the scintillator itself. Spatial resolution is of particular value in applications such as neutron imaging. Spatial resolution is also paramount in the Fermi Large Area Space Telescope (formerly, GLAST) where a high-efficiency segmented scintillation detector employs WSF readout for detection of high-energy cosmic rays, as described in Moiseev, *et al.*, *High efficiency plastic scintillator detector with wavelength-shifting fiber readout for the GLAST Large Area Telescope*, Nucl. Instr. Meth. Phys. Res. A, vol. 583, pp. 372-81 (2007).

[0004] Because of the contexts in which fiber-coupled scintillator detectors have been employed to date, all known fiber-coupled scintillator detectors have counted pulses produced by individual interactions of particles (photons or massive particles) with the scintillator, thereby allowing the energy deposited by the incident particle to be ascertained based on the cumulative flux of light reemitted by the scintillator.

[0005] The detection requirements of x-ray backscatter inspection systems, however, are entirely different from the requirements addressed by existing fiber-coupled scintillation detectors. Backscatter x-ray inspection systems have been used for more than 25 years to detect organic materials concealed inside baggage, cargo containers, in vehicles, and on personnel. Because organic materials in bulk preferentially scatter x-rays (by Compton scattering) rather than absorb them, these materials appear as brighter objects in backscatter images. Insofar as incident x-rays are scattered into all directions, sensitivity far overrides spatial resolution as a requirement, and in most scatter applications, detector spatial resolution is of no concern at all, since resolution is governed by the incident beam rather than by detection.

[0006] The specialized detection requirements of large area and high sensitivity posed by x-ray scatter systems are particularly vexing in the case of “conventional” scintillation detectors **100** of the type shown in a side cross-section in Fig. 1A and in a front cross-section in Fig. 1B. An example of such a detector is described in US Patent No. 5,302,817 (to Yokota). Typically, a light-tight box **102** is lined with scintillating screens **103** where incident x-ray radiation **101** is converted to scintillation light, typically in the UV, visible, or longer wavelength, portions of the electromagnetic (EM) spectrum. Large-photocathode-area photomultiplier tubes (PMTs) **105** are coupled to receive scintillation light via portholes **108**. One problem lies in that a fraction of the scintillation light originating within the screen is transmitted from the screen into the enclosed volume. The remaining scintillation light is lost in the screen material. Scintillating screens **103** are designed to maximize the fraction of emitted light, which is tantamount to ensuring a large transmission coefficient *T* for the interface between screen **103** and the medium (typically air) filling the detector volume. However, in a conventional backscatter detector of the sort depicted in Figs. 1A and 1B, the scintillation screens **103** should also serve as good reflectors because scintillation light, once emitted into the volume of box **102**,

typically needs multiple reflections until it reaches a photo-detector **105**. So, the reflection coefficient R of the screen surface should also be large, however, since the sum of T and R is constrained to be unity, both T and R cannot be maximized simultaneously, and a compromise must be struck. As a result, the light collection efficiency of the conventional backscatter detector is inherently low, with only a few percent of the generated scintillation light collected into the photo detectors.

[0007] For an imaging detector, the photon statistical noise is calculated in terms of the photons absorbed by the detector and used to generate the image. Any photons which pass through the detector without being absorbed, or even those that are absorbed without generating image information, are wasted and do not contribute to reducing noise in the image. Since photons cannot be subdivided, they represent the fundamental quantum level of a system. It is common practice to calculate the statistical noise in terms of the smallest number of quanta used to represent the image anywhere along the imaging chain. The point along the imaging chain where the fewest number of quanta are used to represent the image is called a "quantum sink". The noise level at the quantum sink determines the noise limit of the imaging system. Without increasing the number of information carriers (*i.e.*, quanta) at the quantum sink, the system noise limit cannot be improved. Poor light collection can possibly create a secondary quantum sink, which is to say that it will limit the fraction of incident x-rays resulting in PMT current. Moreover, it will increase image noise. Light collection efficiency can be improved by increasing the sensitive area of the photo-detectors, however, that path to efficiency is costly.

[0008] The structure of scintillating screen typically employed in prior art x-ray scintillation detectors is now described with reference to Fig. 2. A layer of composite scintillator **202** is sandwiched between a backer sheet **204** for structural support and a thin, transparent protective film **206** composed of polyester, for example. The composite scintillator consists of typically micron-size inorganic crystals in an organic matrix or resin. The crystals are the actual scintillating material. Barium fluoro-chloride (BaFCl, or "BFC") or gadolinium oxysulfide (Gd_2O_2S , or "Gadox") doped with rare earth elements are common choices for these. The stopping power of the screen is determined by the thickness of the composite scintillator layer **202**, which is typically measured in milligrams of scintillator crystal per unit area. Because the inorganic scintillators (such as BFC or Gadox) suffer from

high self-absorption, the composite scintillator layer has to be kept rather thin in order to extract a good fraction of the scintillation light. This limits the useful stopping power of the screen and makes it suitable only for the detection of x-rays with energies up to around 100 keV.

[0009] Therefore, it would be advantageous to have a scintillation detector for x-ray scatter detection applications that provides for more efficient extraction, collection, and detection of scintillation light.

[0010] As briefly discussed at the outset above, wavelength-shifting fibers (WSF) have long been employed for scintillation detection. Wavelength shifting fibers consist of a core with relatively high refractive index, surrounded by one or more cladding layers of lower refractive index. The core contains wavelength-shifting material, also referred as dye. Scintillation light which enters the fiber is absorbed by the dye which, in turn, emits light with a longer wavelength. The longer wavelength light is emitted isotropically in the fiber material. Total internal reflection traps a fraction of that light and conducts it over long distances with relatively low loss. This is possible, as described with reference to Fig. 3, because the absorption 304 and emission 302 wavelength ranges of the dye effectively do not overlap so that the wavelength-shifted light is not reabsorbed. The captured fraction is determined by the ratio of the refractive indices at surfaces of the fiber. An additional advantage of WSF is that the wavelength shifting can bring the scintillation light 306 into the sensitive wavelength range of the photo detector (PMT, silicon photomultiplier (SiPM), or Multiple-Pixel Photon-Counter (MPPC), or otherwise).

[0011] Scintillator structures have been produced using many manufacturing technologies, including, for example, die-casting, injection molding (as described by Yoshimura *et al.*, *Plastic scintillator produced by the injection-molding technique*, Nucl. Instr. Meth. Phys. Res. A, vol. 406, pp. 435-41 (1998), and extrusion, (as described in US Patent No. 7,067,079, to Bross, *et al.*).

Summary of Embodiments of the Invention

[0012] In accordance with various embodiments of the present invention, systems and methods are provided that apply fiber-coupled scintillation detectors to problems in backscatter and transmission x-ray inspection.

[0013] For convenience of notation, a wavelength-shifted fiber-coupled scintillation detector may be referred to herein as an “Sc-WSF” detector.

[0014] In a first embodiment of the present invention, a detector of penetrating radiation is provided that has an unpixelated volume of scintillation medium for converting energy of incident penetrating radiation into scintillation light. The detector has multiple optical waveguides, aligned substantially parallel to each other over a scintillation light extraction region that is contiguous with the unpixelated volume of the scintillation medium. The optical waveguides guide light derived from the scintillation light to a photo-detector for detecting photons guided by the waveguides and for generating a detector signal.

[0015] In other embodiments of the present invention, the detector may also have an integrating circuit for integrating the detector signal over a specified duration of time.

[0016] In an alternate embodiment of the invention, a detector of penetrating radiation is provided that has a volume of scintillation medium for converting energy of incident penetrating radiation into scintillation light and a plurality of optical waveguides, aligned substantially parallel to each other over a scintillation light extraction region contiguous with the volume of the scintillation medium. The optical waveguides guide light derived from the scintillation light to a photo-detector that generates a detector signal. Finally, an integrating circuit for integrating the detector signal over a specified duration of time.

[0017] In further embodiments of the invention, the optical waveguides in the foregoing detectors may be adapted for wavelength shifting of the scintillation light and, more particularly, may be wavelength-shifting optical fibers. The scintillation medium may include a lanthanide-doped barium mixed halide such as barium fluorochloride. The photo-detector may include a photomultiplier.

[0018] In yet further embodiments of the invention, the square of the thickness of any of the foregoing detectors, divided by the area of the detector, may be less than 0.001. At least one of the plurality of waveguides may lack cladding and the scintillation medium may

be characterized by an index of refraction of lower value than an index of refraction characterizing the waveguide. The optical waveguides may be disposed in multiple parallel planes, each of the parallel planes containing a subset of the plurality of optical waveguides.

[0019] In other embodiments of the invention, the detector may have a plurality of layers of scintillator medium successively encountered by an incident beam, and the layers may be characterized by distinct spectral sensitivities to the incident beam. Alternating layers of scintillator may include $\text{Li}^6\text{F}:\text{ZnS}(\text{Ag})$ alternating with at least one of fiber-coupled $\text{BaFCl}(\text{Eu})$ and fiber-coupled $\text{BaFI}(\text{Eu})$. A first of the plurality of layers of scintillator medium may be a wavelength-shifting fiber-coupled detector preferentially sensitive to lower-energy x-rays, and a last of the plurality of layers of scintillator medium may be a plastic scintillator.

[0020] Segments of scintillator medium may be disposed in a plane transverse to a propagation direction of an incident beam, and may be distinctly coupled to photo-detectors via optical fibers.

[0021] In accordance with another aspect of the present invention, a method for manufacturing a scintillation detector, the method comprising extruding a shell of scintillating material around an optical waveguide, and, in a particular embodiment, the optical waveguide is a wavelength-shifting optical fiber.

[0022] In an alternate embodiment, a method for detecting scattered x-ray radiation has steps of:

- a. providing a detector characterized by a plurality of individually read-out segments; and
- b. summing a signal from a subset of the individually read-out segments, wherein the subset is selected on a basis of relative signal-to-noise.

[0023] In another aspect of the invention, a method is provided for detecting scattered x-ray radiation. The method has steps of:

- a. providing a detector characterized by a plurality of individually read-out segments; and
- b. summing a signal from a subset of the individually read-out segments, wherein the subset is selected on a basis of a known position of a primary illuminating beam.

[0024] A mobile x-ray inspection system is provided in accordance with another embodiment. The inspection system has a source of x-ray radiation disposed upon a conveyance having a platform and ground-contacting members, and a fiber-coupled scintillation detector deployed outside the conveyance during inspection operation for detecting x-rays that have interacted with the inspected object.

[0025] The mobile x-ray inspection system may also have a fiber-coupled scintillation awning detector deployed above the inspected object during a course of inspection, and the awning detector may slide out from a roof of the conveyance prior to inspection operation. There may also be a skirt detector deployed beneath the platform of the conveyance, and a roof detector for detection of spaces higher than the conveyance, as well as substantially horizontal and substantially upright fiber-coupled scintillator detector segments. The substantially horizontal and substantially upright fiber-coupled scintillator detector segments may be formed into an integral structure.

[0026] In accordance with another aspect of the present invention, an apparatus is provided for detecting radiation incident upon the apparatus, the apparatus comprising:

- a. a plurality of substantially parallel active collimation vanes comprising wavelength-shifted fiber-coupled scintillation detectors sensitive to the radiation for generating at least a first detection signal;
- b. a rear broad area detector for detecting radiation that passes between substantially parallel active collimation vanes of the plurality of active collimator vanes and generating a second detection signal; and
- c. a processor for receiving and processing the first and second detection signals.

[0027] In accordance with an alternate embodiment of the invention, a top-down imaging inspection system is provided for inspecting an object disposed on an underlying surface. The top-down imaging inspection system has a source of substantially downward pointing x-rays and a linear detector array disposed within a protrusion above the underlying surface. The linear detector array may include wavelength-shifted fiber-coupled scintillation detectors.

[0028] In accordance with another aspect of the invention, an x-ray inspection system is provided for inspecting an underside of a vehicle. The x-ray inspection system has a source of substantially upward pointing x-rays coupled to a chassis and a wavelength-shifting fiber-

coupled scintillator detector disposed on the chassis for detecting x-rays scattered by the vehicle and by objects concealed under or within the vehicle. The chassis may be adapted to be maneuvered under the vehicle by at least one of motor and manual control.

Brief Description of the Figures

[0029] The foregoing features of the invention will be more readily understood by reference to the following detailed description, taken with reference to the accompanying figures, in which:

[0030] Figs. **1A** and **1B** show side and front cross-sectional views, respectively, of a “box-type” prior art scintillation detector.

[0031] Fig. **2** is a schematic view of a prior art scintillator screen.

[0032] Fig. **3** depicts spectral relationships among scintillation light and typical wavelength-shifting fiber absorption and emission spectra.

[0033] Fig. **4** is a perspective schematic view of an array of wavelength-shifting fibers sandwiched between scintillator material, in accordance with an embodiment of the present invention.

[0034] Fig. **5** is a cross-sectional schematic view of an array of wavelength-shifting fibers embedded within a matrix of scintillator material, in accordance with an embodiment of the present invention.

[0035] Fig. **6A** is a perspective view of a cylindrical scintillator extruded about a WSF, in accordance with an embodiment of the present invention.

[0036] Fig. **6B** is a schematic depiction of a system for extruding a cylindrical scintillator about a WSF, in accordance with an embodiment of the present invention.

[0037] Fig. **6C** is a cross-sectional view of an extruder for co-extruding a cylindrical scintillator with a WSF, in accordance with an embodiment of the present invention.

[0038] Fig. **7** is a schematic cross-section of a scintillation detector with multiple rows of WSF, in accordance with an embodiment of the present invention.

[0039] Fig. **8** is a top view of a wavelength-shifted fiber-coupled scintillation detector in accordance with an embodiment of the present invention.

[0040] Fig. 9 shows roof and skirt backscatter detectors, stowed in accordance with embodiments of the present invention, while Fig. 10 shows the same detectors deployed during the course of inspection operations.

[0041] Fig. 11 shows an awning detector and a skirt detector for use with a backscatter inspection system in accordance with embodiments of the present invention.

[0042] Fig. 12 is a cross-sectional schematic view of a stack of scintillator layers for use as a high-energy x-ray transmission detector, in accordance with an embodiment of the present invention.

[0043] Figs. 13A and 13B show a layered transmission detector inside a 2-inch-high speed bump, in accordance with an embodiment of the present invention, while Fig. 13C shows a cross section of the detector assembly inserted into the speed bump frame.

[0044] Fig. 14A shows a perspective view of a segmented x-ray transmission detector for measurement of the distribution of detected intensity across the width of an x-ray beam, in accordance with an embodiment of the present invention, while Figs. 14B and 14C show an end-on cross-section and a typical beam profile of the detector of Fig. 14A.

[0045] Fig. 15 is a cross-sectional view of a scintillation detector with multi-energy resolution, in accordance with an embodiment of the present invention.

[0046] Fig. 16 shows a multi-layer scintillation detector for detection of both x-rays and thermal neutrons, in accordance with an embodiment of the present invention.

[0047] Fig. 17 shows a perspective view of a detector with active collimators.

[0048] Figs. 18A and 18B show perspective and cross-sectional views of a WSF-detector used as an active collimator in accordance with an embodiment of the present invention, and Figs. 18C and 18D show an arrangement with independent readouts separated by a light-tight x-ray absorber to distinguish radiation striking each face, in accordance with a further embodiment of the present invention.

[0049] Figs. 19A and 19B shows multiple detectors folding out of a hand-held scanner, in stored and deployed conditions, respectively, in accordance with an embodiment of the present invention.

[0050] Figs. 20A and 20B show a backscatter unit that, by virtue of Sc-WSF detectors in accordance with the present invention, may be slid under a vehicle for under-chassis inspection.

[0051] Figs. 21A and 21B depict the use of a right-angled combination of detectors based on Sc-WSF technology in conjunction with a mobile inspection system and in accordance with an embodiment of the present invention.

Detailed Description of Embodiments of the Invention

[0052] In accordance with embodiments of the present invention, the optical coupling of scintillator material to optical waveguides, and, more particularly, to wavelength-shifting fibers, advantageously enables objectives including those peculiar to the demands of x-ray scatter detection.

Definitions:

[0053] The term "image" shall refer to any unidimensional or multidimensional representation, whether in tangible or otherwise perceptible form, or otherwise, whereby a value of some characteristic (such as fractional transmitted intensity through a column of an inspected object traversed by an incident beam, in the case of x-ray transmission imaging) is associated with each of a plurality of locations (or, vectors in a Euclidean space, typically \mathbb{R}^2) corresponding to dimensional coordinates of an object in physical space, though not necessarily mapped one-to-one thereonto. An image may comprise an array of numbers in a computer memory or holographic medium. Similarly, "imaging" refers to the rendering of a stated physical characteristic in terms of one or more images.

[0054] Terms of spatial relation, such as "above," "below," "upper," "lower," and the like, may be used herein for ease of description to describe the relationship of one element to another as shown in the figures. It will be understood that such terms of spatial relation are intended to encompass different orientations of the apparatus in use or operation in addition to the orientation described and/or depicted in the figures.

[0055] Where an element is described as being "on," "connected to," or "coupled to" another element, it may be directly on, connected or coupled to the other element, or, alternatively, one or more intervening elements may be present, unless otherwise specified.

[0056] The terminology used herein is for the purpose of describing particular embodiments and is not intended to be limiting. The singular forms "a," "an," and "the," are intended to include the plural forms as well.

WSF Detectors

[0057] Referring, first, to Fig. 4, in one embodiment of the invention, a layer of closely spaced parallel wavelength-shifting fibers **400** is sandwiched between two layers **403** of composite scintillating screen. The preferred scintillator material is europium-doped barium fluorochloride (BaFCl:Eu), although other scintillators, such as BaFI:Eu, or other lanthanide-doped barium mixed halides (including, by way of further example, BaBrI:Eu and BaCsI:Eu), may be used within the scope of the present invention. Since scintillator materials employed for x-ray detection typically exhibit very strong self-absorption of scintillation photons, embodiments in accordance with the present invention advantageously allow unusually large volumes of scintillator **403** to be employed while still efficiently coupling out scintillation signal.

[0058] One advantage to using composite scintillation screen in the present application is that it allows for fabrication by extrusion of a fiber-coupled scintillation detector.

[0059] Composite scintillator **403** is structurally supported by exterior layers **404** of plastic, or other material, providing mechanical support. Optical contact between the fiber cladding **401** and the composite scintillator **403** is established by filling the voids with index-matching material **405** of suitable refractive index which is transparent to the scintillation light. The refractive index of the filling material is chosen to optimize the collection of primary light photons into the WSF and the capture of wavelength-shifted photons in the fiber. Filling material **405** may be optical grease or optical epoxy, for example, though any material is within the scope of the present invention.

[0060] Upon incidence of x-ray photons, scintillation light emitted by scintillator **403** is coupled via cladding **401** into core **407** of the respective fibers, down-shifted in frequency (i.e., red-shifted) and propagated to one or more photo-detectors **805** (shown in Fig. 8, for example). Light from the fiber cores **407** is converted into a current via photo-detector **805**, and the current is integrated for an interval of time, typically in the range of 1-12 μ s, to obtain the signal strength for each pixel. Integration of the detector signal may be performed by an integrating circuit (not shown), such as an integrating pre-amplifier, for example.

[0061] Referring now to Fig. 5, wavelength-shifting fibers **400** are embedded in the matrix of the scintillating screen **503**. Embedding the WSF into the scintillating medium creates the best optical contact.

[0062] In yet another embodiment of the invention, described now with reference to Fig. 6A, composite scintillator material **603** is applied like a cladding or shell around a WSF **601** with core **602**. This application lends itself to an extrusion-style manufacturing process and allows making the most effective use of costly scintillator material **603**. The scintillator material **603** is sealed off with a protective layer **604** which also acts as a reflector to the scintillation light. Within the scope of the present invention, the cladding may be omitted when the scintillator has a lower index of refraction than the fiber and the scintillator-fiber bond has the necessary smoothness and robustness.

[0063] A wavelength-shifting polymer optical fiber may be manufactured, in accordance with an embodiment of the invention now described with reference to the system schematic depicted in Fig. 6B. Sources of WSF polymer melt **606**, low-refractive-index cladding polymer melt **608**, and phosphor-embedded optically transparent polymer melt **610**, all under pressure, are fed into a co-extrusion die **612** within extrusion zone **614**, and co-extruded. Dry gas **611**, such as dry air or nitrogen, for example, is sprayed onto the extruded fiber for cooling. Polymer melt with a light-reflective pigment (such as TiO_2 , for example) **616** is fed under pressure into an extrusion die **618** for a light-reflective jacket over the scintillator-coated WSF **613**. The resultant scintillator-loaded WSF **620** is wound for storage by winder **622**. Fig. 6C shows a cross-sectional view of a co-extrusion system, for use in accordance with embodiments of the present invention, for the manufacture of scintillator-coated WSF. The WSF polymer melt **606** is injected, along with the low-refractive-index cladding polymer melt **608** and phosphor-embedded optically transparent polymer melt **610**, into co-extrusion die **612**. Polymer melt with a light-reflective pigment **616** is fed under pressure into extrusion die **618**. The completed fiber has a WSF core **602**, a low-index cladding **601**, a scintillator-loaded cladding **603**, and a reflective coating **604**.

[0064] For all embodiments of a scintillation detector in accordance with the present invention, it is advantageous that the thickness of the scintillator material be optimized for the energy of the radiation to be detected. The design should ensure sufficient light collection

to avoid a secondary quantum sink. In particular, embodiments of the invention described herein provide for detectors of extraordinary thinness relative to their area.

[0065] *Definitions:* For purposes of the present description, and in any appended claims, the term “thickness,” as applied to a scintillation detector, shall represent the mean extent of the detector in a dimension along, or parallel to, a centroid of the field of view of the detector. The term area, as applied to a detector, or, equivalently, the term “active area” shall refer to the size of the detector measured in a plane transverse to centroid of all propagation vectors of radiation within the field of view of the detector.

[0066] Embodiments of the present invention, even those with as many as 8 WSF layers, have ratios of the square of detector thickness to the active detector area that are less than 0.001. For example, an 8-layer detector with an area of 48 " × 12" has a thickness no greater than 0.5 ", such that the ratio of the square of the thickness to the detector area is 0.0005. This thickness-squared-to-area ratio is typically an order of magnitude, or more, smaller than the comparable ratio for backscatter detectors where scintillator light is directly detected by a photo-detector.

[0067] In accordance with a further embodiment of the invention depicted in Fig. 7, the useful stopping power of the detector can be increased by combining multiple layers **701**, **702** of WSF **400** (or other optical waveguides thereby increasing the depth of scintillator material **403** along the path of the incident radiation.

[0068] An embodiment of a wavelength-shifted scintillator detector in accordance with the present invention is shown in Fig. 8. Wavelength-shifting fibers **801** are embedded within scintillator material **803**, coupling light, and downshifting it in frequency for detection by photomultiplier tubes **805**.

[0069] In accordance with various of the embodiments heretofore described, the ends of the WSF are bundled and optically coupled to at least one photo detector. Examples of suitable photo detectors include PMTs and silicon photomultipliers (SiPMs).

[0070] Advantages of the detector, the invention of which is described herein, include the efficiency of detection, and the low geometrical profile of implementation. This allows greater freedom in designing a detection system and it makes entirely new, space constrained applications possible. The mechanical flexibility of the detector structure allows shaping the detector surface to conform to the application, such as an implementation in

which an imaged object is surrounded by detector volume. The low profile also makes it relatively easy to orient and shield the detector area in ways to minimize the detection of unwanted scatter radiation (crosstalk) from a nearby x-ray imaging system.

[0071] The extraction of scintillation light over a large region of scintillator enables detectors of large width-to-depth aspect ratio. In particular, detectors subtending spatial angles of 0.1 sr, or more, are facilitated by embodiments of the present invention.

[0072] In a typical backscatter x-ray imaging system, an x-ray pencil beam scans an imaged target in a linear motion, while elongated radiation detectors are arranged on both sides of an exit aperture of an x-ray source. As the pencil beam moves, the detector area closest to the beam will typically receive the strongest signal and detector area further from the beam less. If the detector area is segmented into individually readable sections the signal to noise ratio of the detection system can be improved by only reading the segments with a good signal to noise ratio and neglecting the segments which would contribute predominantly noise to the summed signal. The selection of contributing detector segments can be made based on the actually detected signal or based on the known position of the pencil beam.

Advantages of Scintillator Fabrication by Extrusion

[0073] The extrusion, or “automated coating” process, described above with reference to Figs. 6A-6C, is in stark contrast to typical methods of laying down polycrystalline scintillation material, such as BaFCl(Eu), on a flat backing. The extrusion method of fabricating individual wavelength-shifting fibers coated with a uniform thickness of scintillator, as taught above, produces fibers that can be contoured so that the restrictions on the shape of a Sc-WSF detector is governed primarily by the requirement of full capture in the fiber by total internal reflection. The concept of uniformly coated coupling fibers gives greater freedom to the design of backscatter (BX) detectors, especially hand-held and robot-mounted detectors, where space is at a premium.

Deployable Detectors to increase geometric efficiency of scattered x-rays

[0074] Some mobile x-ray systems, such as those described, for example, in US Patent Nos. 5,764,683, to Swift, *et al.* and 7,099,434, to Chalmers *et al.*,

use the method of backscattered x-rays (BX) to inspect cars and trucks from one side. The former uses detectors deployed outside a conveyance during operation, whereas the latter uses a detector area entirely contained within an enclosure, namely the skin of a conveyance. Both use large-area detectors to maximize the efficiency of detecting the scattered x-rays. The areal backscatter detector coverage in the case of a product in accordance with the teachings of the Chalmers '434 Patent covers on the order of 20 square feet of the interior surface of an enclosure that faces the target. This covert detector area has relatively poor geometrical efficiency for collecting the scattered radiation from high or low targets. The intrinsically deep geometrical profile of such detectors, necessary for direct capture of the scintillation light by photomultipliers, is inimical to deployment outside the van.

[0075] *Definitions:* As used herein, and in any appended claims, the term “large-area detector” shall refer to any single detector, or to any detector module, subtending an opening angle of at least 30° in each of two orthogonal transverse directions as viewed from a point on an object undergoing inspection, equivalently, characterized by a spatial angle of at least π steradians.

[0076] A “conveyance” shall be any device characterized by a platform borne on ground-contacting members such as wheels, tracks, treads, skids, etc., used for transporting equipment from one location to another.

[0077] An Sc-WSF detector, in accordance with embodiments of the present invention, makes practical the unobtrusive storage of large-area detectors that can be quickly deployed outside the van in positions that substantially enhance detection efficiency.

[0078] Referring, now, to Fig. 9, a large-area Sc-WSF awning detector **1101** is shown in a stowed position, stored on the roof of a backscatter inspection van **1103**, and a thin skirt detector **1105** is shown in a stowed position above a wheel of the backscatter inspection van. In Fig. 10, both the roof and skirt detectors are shown as deployed to increase the solid angle for detecting higher and lower targets, respectively; the awning detector is deployed above an inspected object during the course of inspection, while the skirt detector is deployed, at least in part, beneath the platform of the conveyance. In another embodiment of the invention, described with reference to Fig. 11, an awning detector **1301** may be deployed for low, close targets, such as for detection of contraband in the trunk or far side of a car **1303**. Awning

detector **1301** may slide out from a roof of the conveyance prior to inspection operation. Fig. 11 also shows the deployment of Sc-WSF skirt detectors **1105** used to efficiently examine the tires, wheel wells, and the interior of close vehicles.

Dual and multi-energy detectors for transmission detection of scanning x-ray pencil beams

[0079] Scanning pencil beams of x-rays not only reveal interior objects by analyzing the backscattered radiation but, in some applications, can obtain additional information by the simultaneous analysis of transmission (TX) and forward scattered (FX) radiation. The TX and FX detectors need not be segmented since the cross-sectional area of the pencil beam, together with the integration time of the signal, defines the pixel size. Moreover, the TX and FX detectors only need to be total energy detectors since, in most applications, the flux of the TX or FX x-rays is too high for pulse counting. Scintillation screens are the traditional detectors for such scanning beam applications. Sc-WSF detectors substantially extend the range of applications of present TX and FX scintillation detectors, as the following examples make clear.

TX for x-ray beams up to at least 250 keV

[0080] The absorption efficiency of traditional scintillation screens, made, for example, of BaFCl(Eu) or Gadox, drops below 50% for x-ray energies above ~80 keV. The 50% point for two layers is about 100 keV. By way of distinction, Sc-WSF detector can be made with more than two layers of scintillators without substantially increasing the profile of the detector. A cost-effective Sc-WSF detector, with 4 layers, can be used for TX with scanning x-ray beams generated by a standard 140 keV x-ray tube. A multi-layer detector such as the 9-layer detector, as shown in Fig. 12, and designated there generally by numeral **1400**, can be highly effective for a detecting x-rays **1402** emitted by a standard 225 keV x-ray tube (not shown), such as that used in the x-ray inspection of vehicles through portals. Layers **1404** of scintillator material are shown, and WSF fibers **1406** coupled to photo-detectors **1408**.

Transportable TX detector for Top-Down Imager in three-sided portal inspection

[0081] The thin profile of the multi-layer transmission (TX) detector makes practical a top-of-the-road transmission (TX) detector. Figs. 13A and 13B show such a detector inside a 2-inch-high speed bump **1131** strong enough to support a fully-loaded tractor trailer, and requiring no excavation of the ground for deployment. Source **1132** of penetrating radiation emits fan beam **1134** incident upon a linear detector assembly **1135** within frame **1136** of speed bump **1131** or a similar protrusion above an underlying surface. Detector assembly **1135** includes segments of scintillator material **1137** separated by vanes **1138** of high atomic number. As described above, for example with reference to Fig. 4, scintillation light is coupled to photo-detectors by means of wave-length shifting optical fibers **1139**.

Segmented TX detector for determining the scan beam intensity profile

[0082] Referring now to Figs. 14A and 14B, a segmented transmission detector, designated generally by numeral **1141**, is shown for measuring a scan beam intensity profile of incident x-rays **1143**. Alignment of the Sc-WSF detector **1141** (used in transmission) with the plane of a scanning pencil beam presents a significant challenge when the TX detector is deployed for a mobile security system. Fig. 14B shows a cross section of a vertical Sc-WSF detector **1141** (otherwise referred to herein, when appropriate, as a “transmission detector” or “TX detector”) with independent read-out of the fibers **1145** of the WSFs, provides the means to simultaneously measure both the transmitted intensity of each pixel and the linear distribution across the beam width to determine its centroid position. Fibers **1145** are routed in bundles **1147** to individual photo-detectors **1149** such as PMTs. The distribution of the intensity can extend out to obtain the forward scattered intensity, which contains useful information as to the scattering material, and gives a measure of the in-scattered radiation that is being counted as Transmission intensity.

[0083] The relative position of the detector plane and the plane of scanning x-rays can be controlled automatically. The detector for this concept is shown schematically in Fig. 14A. A reflecting surface **1148** may be provided at an end of detector **1141** distal to photo-detectors **1149**.

[0084] With a single data channel for a transmission signal, the spatial resolution along the traffic direction (transverse to a fan-shaped illuminating x-ray beam) is determined by the smaller of the following two dimensions: the width of the sensitive detector area or the

beam size across the TX detector. (For heuristic purposes, the case of undersampling is not considered in this description.) Spatial resolution may be improved, however, by narrowing the sensitive detector area, as now described with reference to Fig. 14C. In accordance with embodiments of the present invention, the spatial resolution across the direction of traffic (along the detector line) is enhanced by employing multiple detectors of a detector array **1450** associated with a plurality of channels (A, B, C, in Fig. 14C) and interlacing their sensitive areas. The pitch of the interlace pattern depends on the beam width along the detector. Ideally the pitch (*i.e.*, the spacing between two detectors **1451** and **1454** associated with a single channel “A”) has to be large enough so that two detector segments of the same detection channel do not receive direct radiation from the beam at the same time. The beam intensity profile is depicted by numeral **1456**. For practical purposes the requirement is not as stringent, since some amount of crosstalk between pixels is acceptable. The multiple, resulting images need to be interlaced, employing any method, including methods well-known in the art, to create one higher-resolution image. It should be noted that improvement of the spatial resolution at the detector comes at the expense of flux and is, thus, limited by signal-to-noise considerations.

[0085] Another configuration within the scope of the present invention include a combination of the vertical detector **1141** shown in Fig. 14A with horizontal road detector **1135** of Fig. 13B to form an L-shaped detector that is advantageously easily set up and aligned.

[0086] In yet another embodiment of the invention, a transmission detector array **1450** (regardless of geometrical orientation, whether vertical, horizontal, L-shaped, etc.) is segmented into a plurality of units; such as B, C and A of Fig 14C. As shown, the beam profile **1456** is symmetric with respect to B and A so that the ratio of the measured intensities is unity. If, for any reason, the alignment changes, that ratio changes dramatically. If the alignment skews as an illuminating x-ray pencil beam scans up and down, the change in the ratio of B/A measures the both the skewness and the lateral shift. Collected data can then be corrected for such a shift on a line-by-line basis.

Dual-energy and multi-energy TX detectors for material identification

[0087] Separating the signals from front and back layers of scintillators allows the front layer to give a measure of the low-energy component of each pixel while the back layer gives a measure of the high-energy components. Putting a layer of absorbing material between the front and back scintillators is a standard way to enhance the difference between low and high energy components, and that is easily done with a Sc-WSF detector.

[0088] The Sc-WSF detector makes practical a dual-energy detector consisting of a layer of Sc-WSF, such as BaFCl-WSF, on top of a plastic scintillator detector; the BaFCl is sensitive to the low-energy x-rays and not the high-energy x-rays, while the plastic detector is sensitive to the high-energy x-rays and very insensitive to low energy x-rays.

[0089] An alternative and potentially more effective material discriminator can be made by using more than two independent layers of Sc-WSF, with separate readouts for each layer. A passive absorber, such as an appropriate thickness of copper, can be inserted after the top Sc-WSF to enhance dual energy application, as is practiced with segmented detectors. Alternatively, the middle scintillator can be used as an active absorbing layer. The measurement of three independent parameters allows one to get a measure of both the average atomic number of the traversed materials and the extent of beam hardening as well. The Sc-WSF can be further extended to obtain more than three energy values for each pixel, the limit being the statistical uncertainties, which increase with the number of components. Detector 1400 shown in Fig. 12 is an extreme example of such a detector.

[0090] An important application of Dual-Energy TX is for x-ray personnel scanners at airport terminals. Providing TX images simultaneously with BX has proved useful for inspection. Adding dual-energy to the TX images has hitherto been impractical primarily because of size constraints imposed by conventional detectors. Sc-WSF eliminates those constraints and promises to significantly improve performance, since multiple detectors, with distinct energy sensitivities, may be stacked, as shown in Fig. 15, where a dual- (or multi-) energy detector 1500 includes an Sc-WSF detector 1508, sensitive to a lower energy component of incident x-rays 1501, positioned in front of a slab of plastic scintillator 1502, which is sensitive to the higher energy x-rays. Sc-WSF detector 1508 contains a scintillator 1504 read out by two layers of WS fibers 1506.

Compact radiation detector of gamma and neutron radiation

[0091] The Sc-WSF method makes practical a small, lightweight, inexpensive, monitor of neutrons and gamma rays **1601**. BaFCl(Eu)-WSF is quite sensitive to gamma radiation while being insensitive to neutrons, while Li⁶F:ZnS(Ag)-WSF is insensitive to gamma rays and quite sensitive to detecting thermal neutrons. Fig. 16 shows a multi-layer “Dagwood” sandwich consisting of one or more layers **1602** of BaFCl(Eu), read out by a single photo-detector (not shown) via optical fibers **1604**, and one or more layers **1606** of Li⁶F:ZnS(Ag)-WSF, read out by a second, independent, photo-detector (not shown), with the active elements occupying a thickness of no more than one or two centimeters. An appropriate layer of neutron moderator **1612**, such as polyethylene, may be placed on either side of the Li⁶F:ZnS(Ag)-WSF to enhance the efficiency for detecting neutrons. Optically reflective foil **1608**, such as aluminum foil, confines scintillation to respective detector regions.

[0092] US Patent Application, Serial No. 13/163,854 (to Rothschild), entitled “Detector with Active Collimators,” describes a backscatter detector module **30** that increases the depth of inspection by distinguishing scatter from the near and far field of inspected objects, as depicted in Fig. 17. The angle of a set of active collimating vanes **31** may either be adjusted once at the factory, or may be attached to any kind of electro-mechanical device provided to dynamically adjust them, depending on the type and/or distance of the object being scanned. The scintillation light from the collimating vanes is detected by one or more photo-detectors (for example, by PMTs **32** located at the top and bottom of the front compartment of the detector). A rear compartment **36** of the detector is optically isolated from a front compartment **35** by a light baffle **34**, and scintillation light from x-rays detected in rear compartment **36** are collected by a second set of one or more photo-detectors (for example, PMTs **37** mounted on the rear face of the detector). The rear compartment may be lined with scintillating phosphor screen, for example, or, in other embodiments of the invention, may contain plastic or liquid scintillator.

[0093] A useful addition to a standard backscatter unit would be a “venetian blind” collimator made of scintillator. The slats intercept radiation that does not enter directly through the gaps between the slats so that the box detectors preferentially detect deeper interior objects. The active collimators record the rejected radiation. The light from the active collimators is detected by PMTs, whose collection efficiency decreases rapidly as the gap

between collimators decrease. Replacing the PMTs and scintillator vanes with vanes consisting of Sc-WSF detectors solves major shortcomings and makes venetian-blind collimators practical. First, light collection is independent of the gap width between vanes. Second, the active area of the PMTs or silicon photomultipliers used to collect the light from the active collimators is generally much smaller than the active area of needed PMTs, so that the cost of the photo-detectors is less. Third, the placement of the photo-detector at the end of the WSF bundles is not critical to the efficiency of the light collection. Fourth, the signals from the WSFs from each slat can be processed independently, giving considerable scope for maximizing the information about the interior of the inspected object. Fifth, the light from the thin scintillator screens on the front and back of each vane can be collected by independent WSFs, which can significantly improve the depth discrimination.

[0094] Figs. 18C and 18D depict (in perspective and in cross section, respectively) an active WSF collimator **181** sensitive to x-rays impinging from either side of the scintillator. Scintillation light from both scintillator regions **182** is coupled to photo-detectors via waveshifting optical fibers **183**. Figs. 18A and 18B show (in perspective and in cross section, respectively) an active WSF collimator **185** with independent readouts **187** separated by a light-tight x-ray absorber **189** to distinguish radiation striking each face. For example, each collimator **185** may consist, in one embodiment, of two layers of Sc-WSF detectors **182**, each containing an areal density of 60mg BaFCl:Eu per cm². The light-tight x-ray absorber **189** may consist of a thin layer of tin, which also provides structural support.

Detectors for mini-backscatter inspection systems

[0095] The thinness of Sc-WSF detectors provides a unique potential for applications in which low weight and power are drivers. Referring to Figs. 19A and 19B, a hand-held imaging system **193** is an example of such an application. The power requirements, inspection time, and, quality of the image, are all affected by the solid angle of detection. A traditional detector with, for example, a cross-section of 10cm × 10cm (100 cm²), weighs about a half a kilogram. A 10-cm cube of Sc-WSF, weighing no more than twice as much, can be made of individual Sc-WSF 10 cm × 10 cm detectors, each less than 5mm thick, that can be unfolded to present a backscatter detection area of at least 2,000 cm², a twenty-fold

increase in this example. The additional detection coverage can make an order of magnitude improvement in the hand-held system's performance.

[0096] The thin profile of Sc-WSF detectors described herein provide for fitting contoured detectors into tight spaces. For example, detectors may be adapted for personnel scanners constrained to fit into constricted airport inspection spaces.

[0097] Fig. 19 shows an example in which four detectors **191** fold or slide out of hand-held scanner **193** to substantially increase the detection efficiency, especially for items concealed deeper in the object being inspected. Backscatter detectors **195** straddle irradiating beam **197**.

Back-scatter inspection of the underside of stationary vehicles

[0098] The inspection of the underside of vehicles by a portable x-ray backscattering system presents special problems. The road clearance of cars is not more than 8" and can be as little as 6". Fixed inspection systems, such as portals, can place a detector in the ground, or, as described above, can be placed on the ground using Sc-WSF. Mobile under-vehicle inspection systems, however, which are needed for security in many areas, have never been developed. Inspectors rely on passive inspection tools such as mirrors and cameras, which miss contraband in the gas tank or are camouflaged to appear innocuous.

[0099] The Sc-WSF detectors make practical an x-ray backscatter system that is not more than 6" high. A sketch of a practical system is now described with reference to Figs. 20A and 20B. The x-ray source consists of an electromagnetic scanner **221** of an electron beam across an anode. Electromagnetic scanner **221** is driven by electronics module **223**. The x-rays are collimated by a linear array of apertures **225** that span, for example, 30" of the underside in one pass. The Sc-WSF detectors **227** are mounted on each side of the x-ray tube so as detect x-rays **236** backscattered from vehicle **229**. Power supplies, pulse and image processors can be mounted appropriately. Chassis **234** of inspection unit **230** on wheels **232** may be adapted to be maneuvered under vehicle **229** by motor or manual control.

Mobile transmission inspection with L-shaped detector array segments

[00100] In accordance with another aspect of the present invention, a mobile inspection system, designated generally by numeral **240**, is now described with reference to

Figs. 21A and 21B. A source of penetrating radiation (not shown, and described, herein, without limitation, in terms of x-rays) is conveyed within a mobile inspection unit **241**, which, typically, is capable of motion under its own power, although it may also be towed or otherwise transported, within the scope of the present invention. A beam **242** of penetrating radiation is emitted from mobile inspection unit **241**, either as a swept pencil beam or as a fan beam, in either case emitted in the plane designated as representing beam **242** in Fig. 21A. Inspected object **244**, which may be a vehicle as shown, or otherwise (such as hauled cargo), traverses beam **242** during the course of inspection, and, in the course of traversal, passes over an integral L-shaped detector unit **245**, as now further described. Detector unit **245** has a horizontal segment **246** and an upright segment **247**, as indicated in Fig. 21B.

[00101] Each of the horizontal and upright segments **246** and **247** of L-shaped detector unit **245** may be comprised of multiple parallel layers **249**, providing for dual- or, more generally, multiple-, energy resolution of detected x-rays, so as to provide material identification, as described above with reference to Fig. 12. Additionally, upright detector array segment **247** may have multiple detector segments **248** in a direction transverse to the direction of beam **242** and substantially along the direction of relative motion between inspected object **244** and beam **242** so as to provide an indication of skewness or lateral shift of the detectors with respect to the beam, as described above with reference to Figs. 14A-14C. Integral L-shaped detector unit **245** may be conveyed to a site of inspection aboard mobile inspection unit **241** or on a towed, or otherwise accompanying, trailer **250**, and may be assembled, in part, upon deployment at the inspection site. Supplemental alignment aids, such as alignment laser **251**, may be employed in establishing proper position and orientation of detector unit **245** relative to mobile inspection unit **241** and beam **242**.

[00102] Where examples presented herein involve specific combinations of method acts or system elements, it should be understood that those acts and those elements may be combined in other ways to accomplish the same objectives of x-ray detection. Additionally, single device features may fulfill the requirements of separately recited elements of a claim. The embodiments of the invention described herein are intended to be merely exemplary; variations and modifications will be apparent to those skilled in the art.

All such variations and modifications are intended to be within the scope of the present invention as defined in any appended claims.

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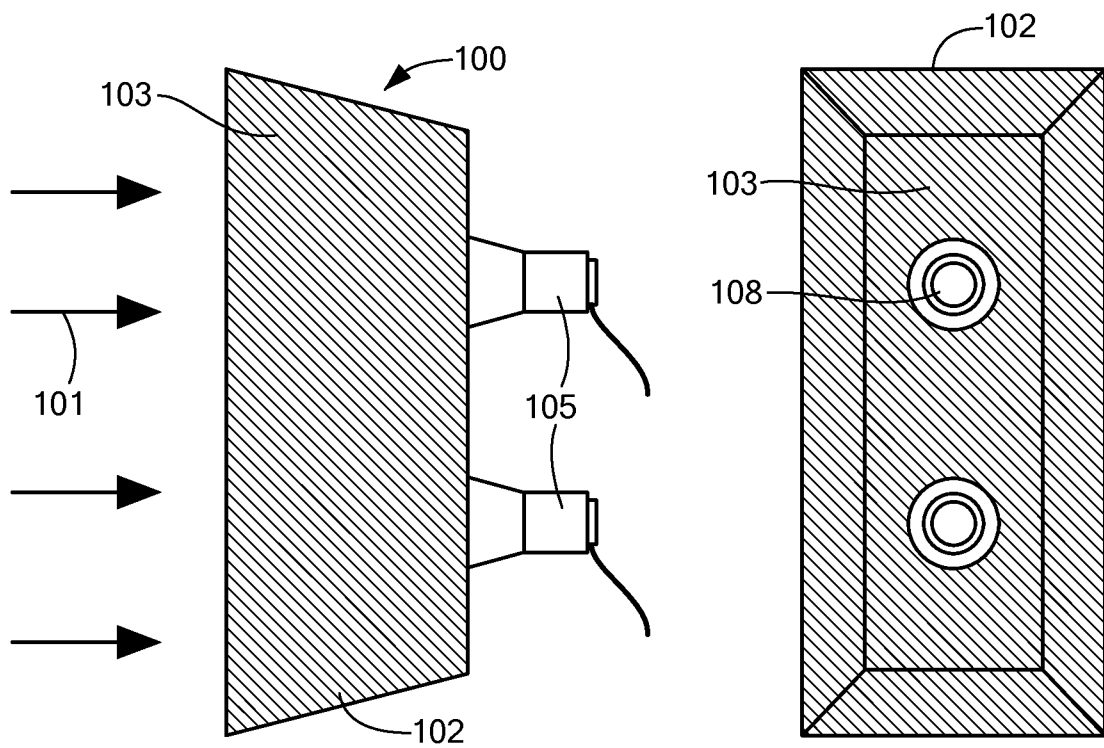
What is claimed is:

1. An x-ray detector characterized by a thickness and an area, the x-ray detector comprising:
 - a. a first volume of scintillation medium for converting energy of incident x-ray radiation into a first scintillation light;
 - b. a first plurality of wavelength-shifting optical waveguides, aligned substantially parallel to each other over a first scintillation light extraction region contiguous with the first volume of scintillation medium, for guiding light derived from, and at a first wavelength longer than that of, the first scintillation light;
 - c. a second volume of scintillation medium for converting energy of incident x-ray radiation that has traversed the first volume of scintillation medium into a second scintillation light;
 - d. a second plurality of wavelength-shifting optical waveguides, aligned substantially parallel to each other over a second scintillation light extraction region contiguous with the second volume of scintillation medium, for guiding light derived from, and at a second wavelength longer than that of, the second scintillation light;
 - e. a first photo-detector for detecting photons at the first wavelength guided by the first plurality of waveguides and for generating a first detector signal; and
 - f. a second photo-detector for detecting photons at the second wavelength guided by the second plurality of waveguides and for generating a second detector signal.
2. An x-ray detector according to claim 1, further comprising an integrating circuit for integrating the detector signal over a specified duration of time.
3. An x-ray detector according to claim 1, wherein at least one of the first scintillation medium and the second scintillation medium includes a lanthanide-doped barium mixed halide.
4. An x-ray detector according to claim 1, wherein at least one of the first scintillation medium and the second scintillation medium includes barium fluorochloride.

5. An x-ray detector according to claim 1, wherein the photo-detector includes a photomultiplier.
- 5 6. An x-ray detector according to claim 1, wherein a square of the thickness of the detector divided by the area of the detector is less than 0.001.
7. An x-ray detector according to claim 1, wherein at least one of the wavelength-shifting optical waveguides lacks cladding and the scintillation medium from which
10 the light guided by the at least one wavelength-shifting optical waveguides is derived is characterized by an index of refraction of lower value than an index of refraction characterizing the at least one wavelength-shifting optical waveguide.
8. An x-ray detector according to claim 1, wherein the pluralities of optical waveguides
15 are disposed in multiple parallel planes, each of the parallel planes containing a subset of the pluralities of optical waveguides.
9. An x-ray detector according to claim 1, wherein the first and second volumes of scintillation medium are characterized by distinct spectral sensitivities to the incident
20 beam.
10. An x-ray detector according to claim 1, wherein alternating volumes of scintillation medium include $\text{Li}^6\text{F}:\text{ZnS}(\text{Ag})$ alternating with at least one of fiber-coupled $\text{BaFCl}(\text{Eu})$ and fiber-coupled $\text{BaFI}(\text{Eu})$.
- 25 11. An x-ray detector according to claim 1, wherein the first volume of scintillation medium is a wavelength-shifting fiber-coupled detector preferentially sensitive to lower-energy x-rays, and the second volume of scintillation medium, which is the last of a plurality of layers of scintillator medium, is a plastic scintillator.
- 30 12. An x-ray detector according to claim 1, further comprising a plurality of segments of scintillation medium disposed in a plane transverse to a propagation direction of an incident beam.

13. An x-ray detector according to claim 12, wherein the plurality of segments of scintillation medium are distinctly coupled to photo-detectors via optical fibers.

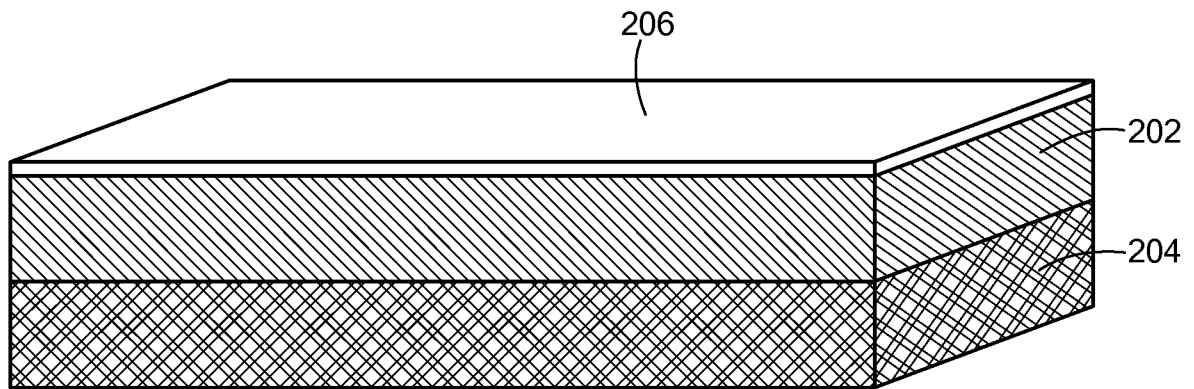
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**FIG. 1A**

PRIOR ART

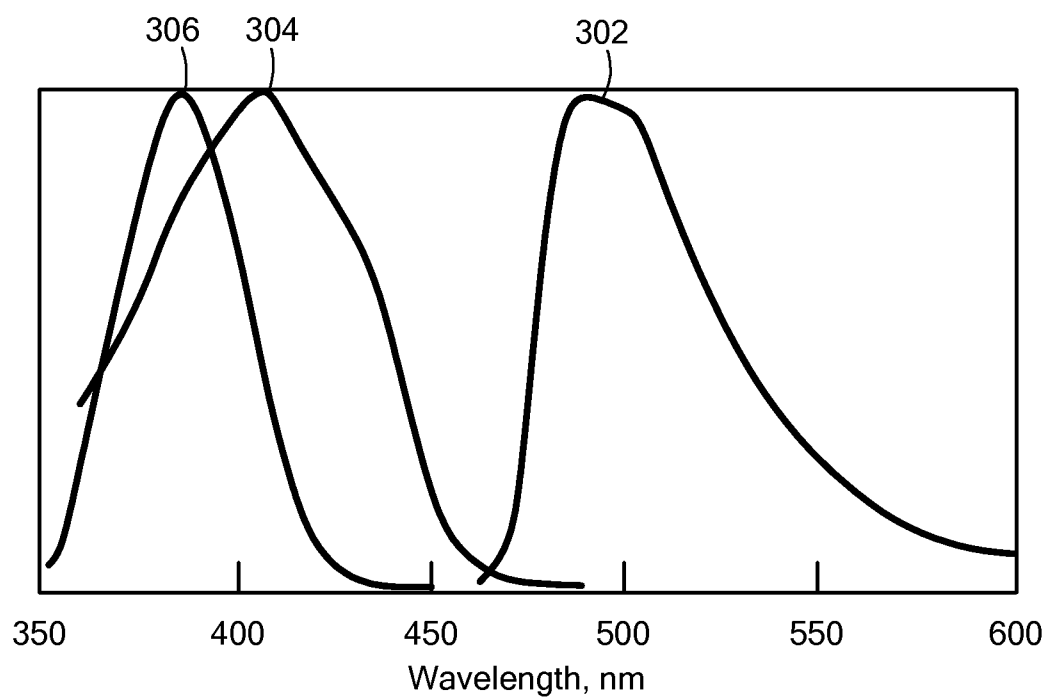
FIG. 1B

PRIOR ART

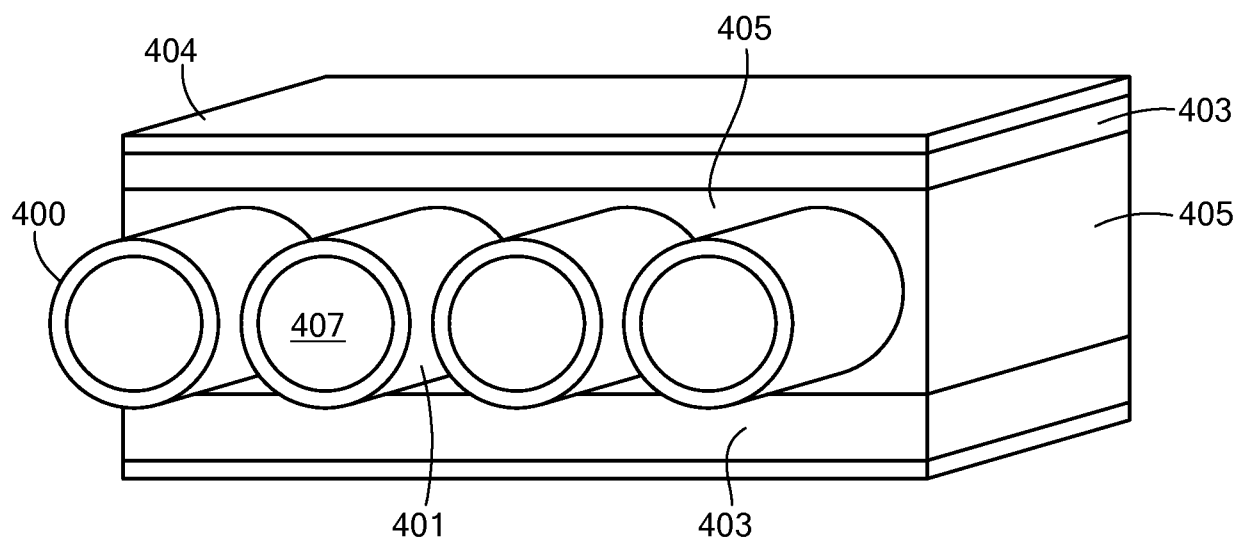
**FIG. 2**

PRIOR ART

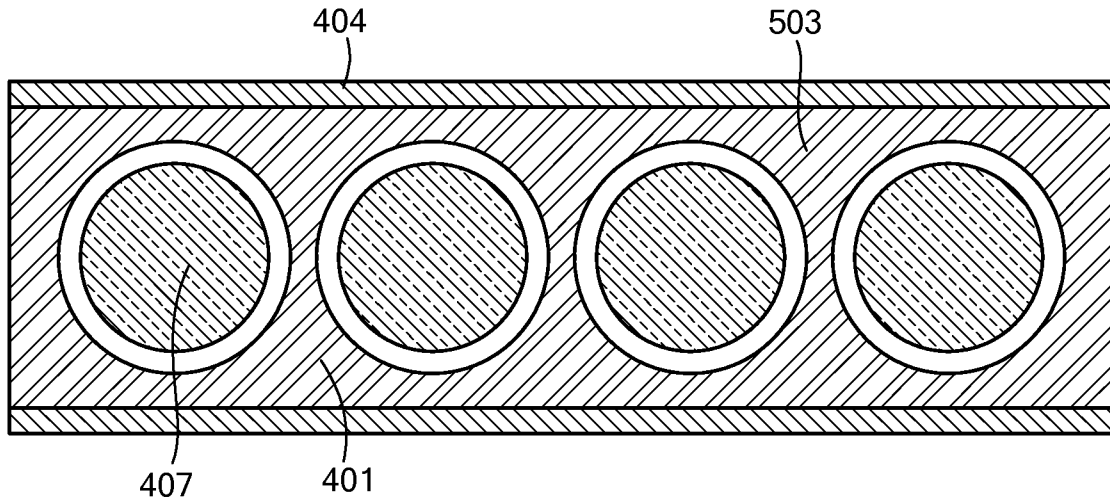
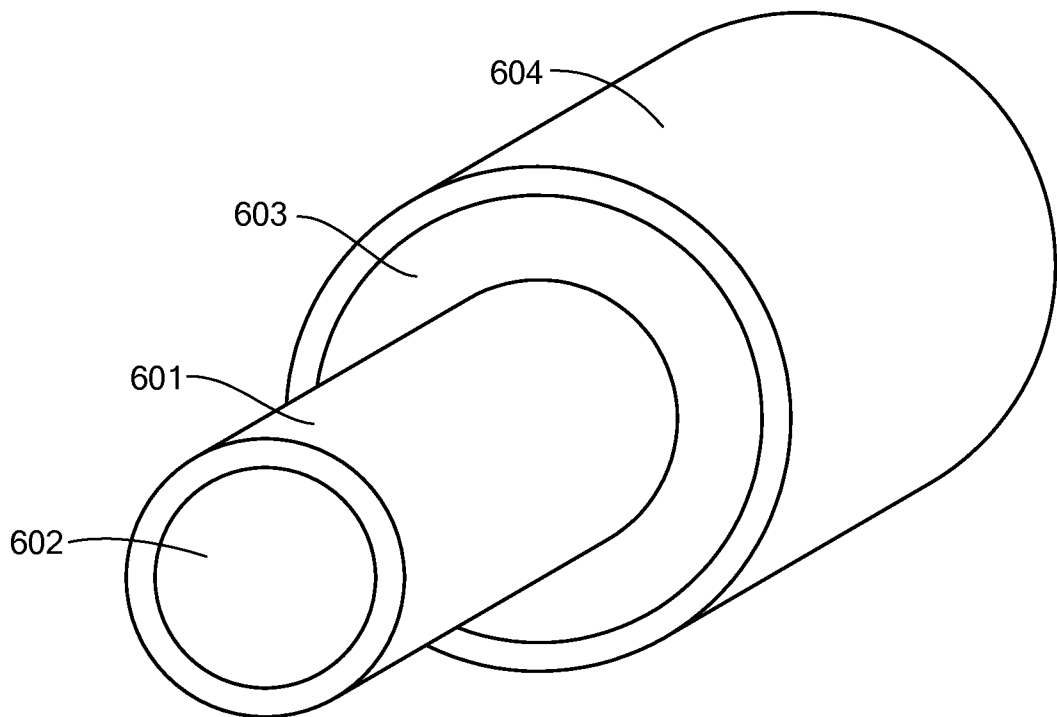
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**FIG. 3**

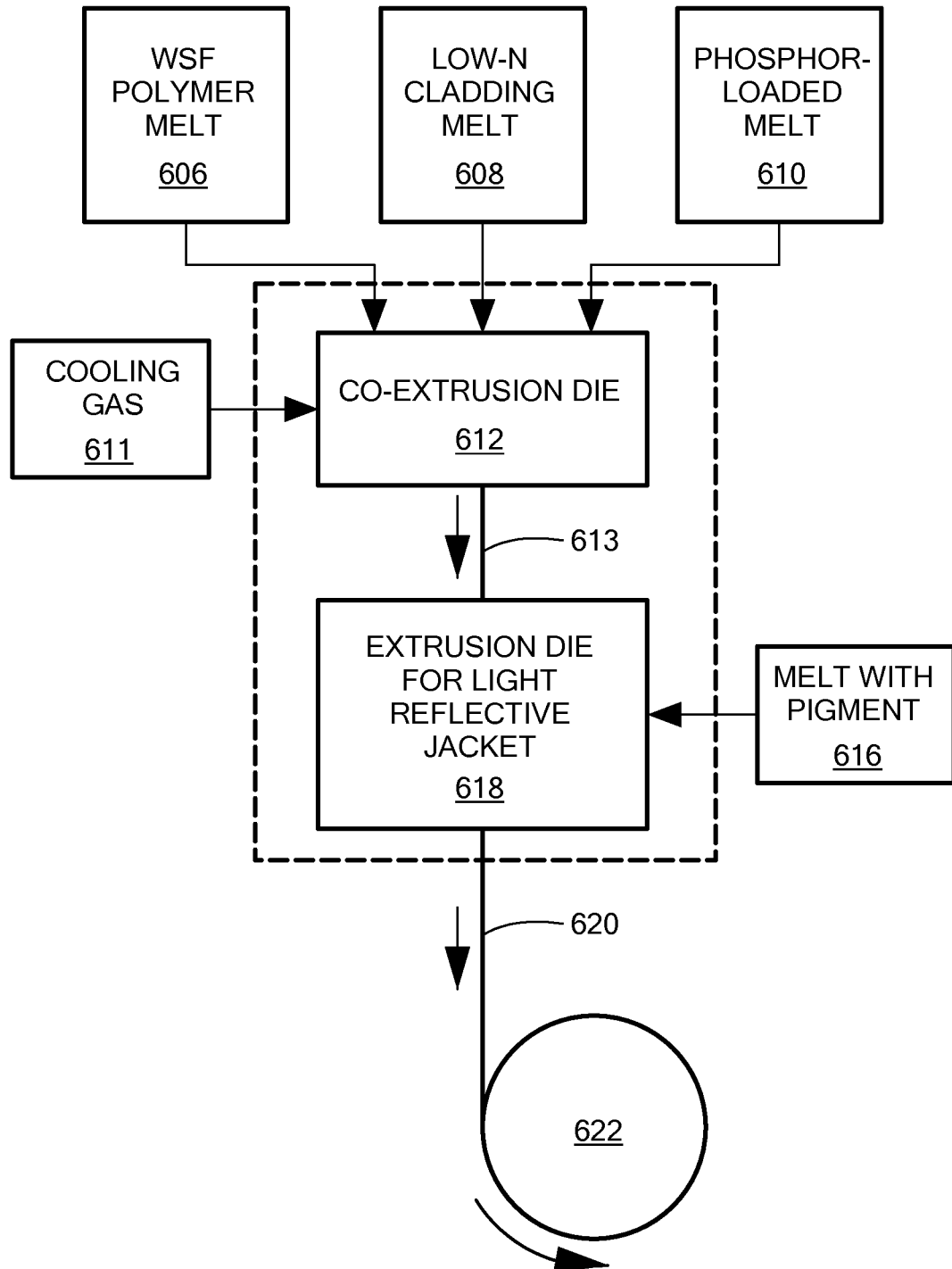
PRIOR ART

**FIG. 4**

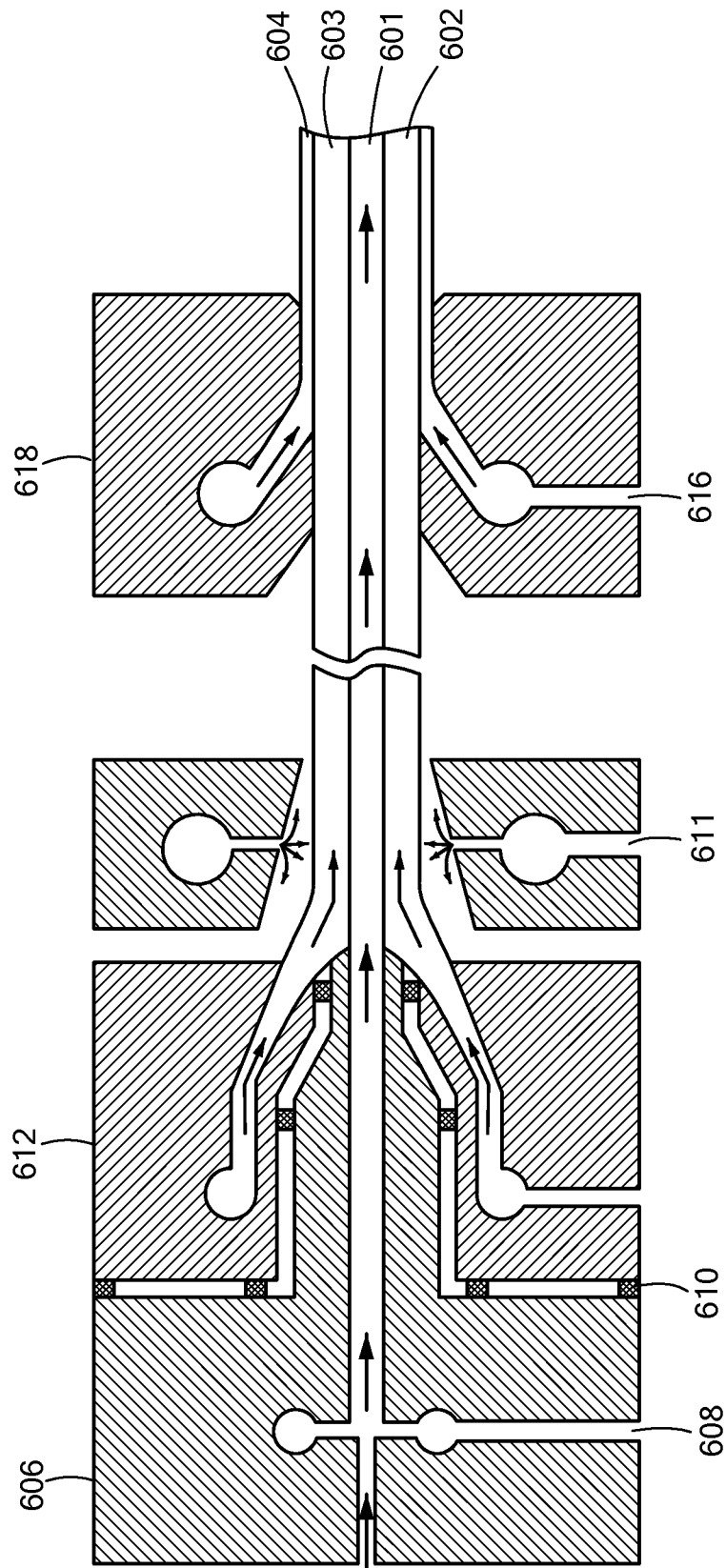
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**FIG. 5****FIG. 6A**

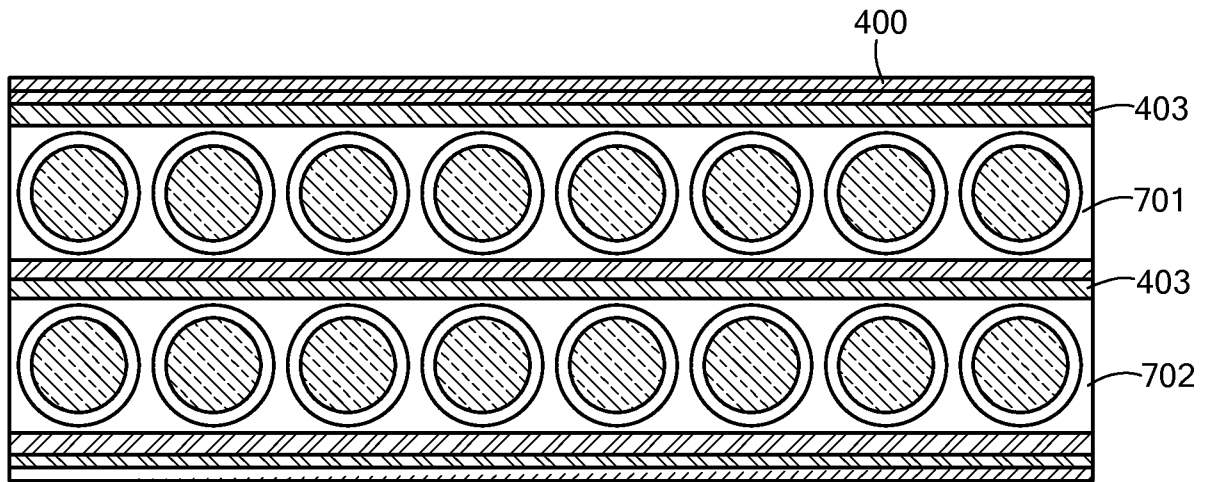
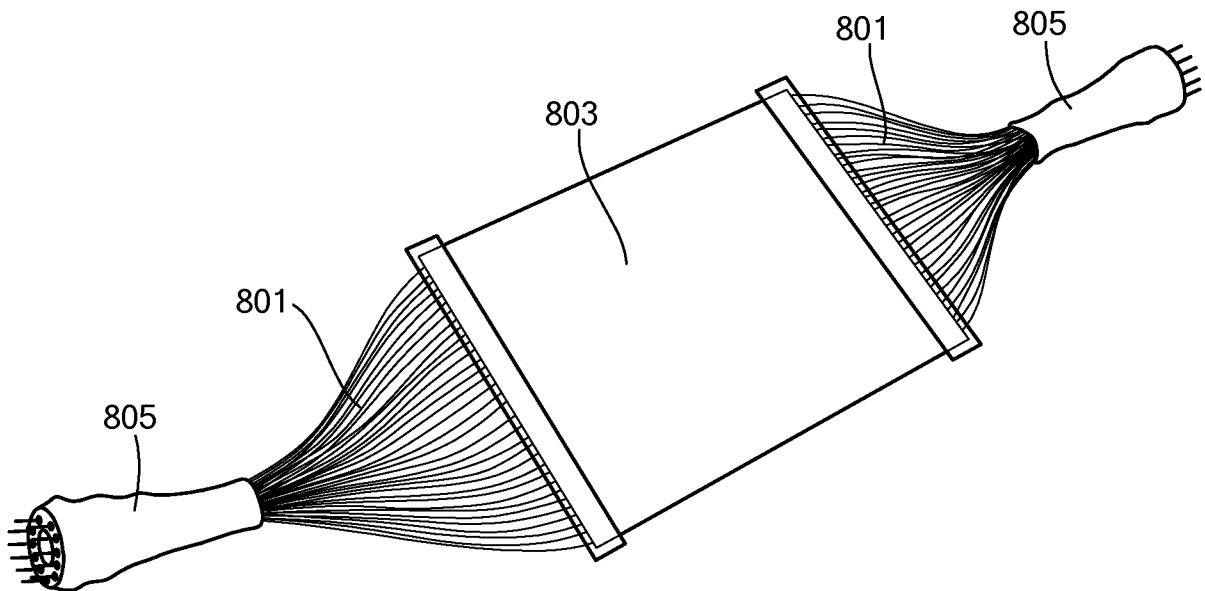
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**FIG. 6B**

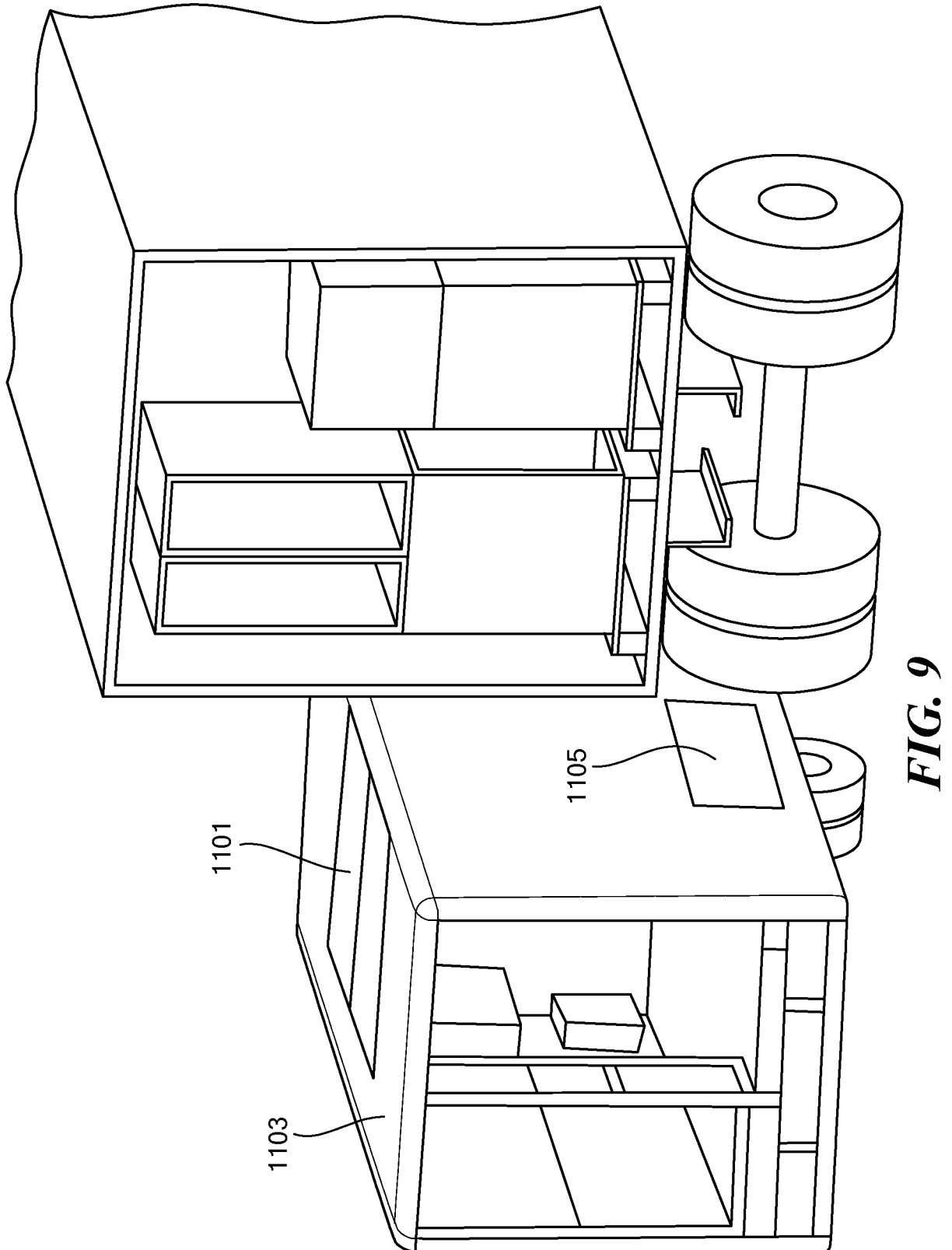
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**FIG. 6C**

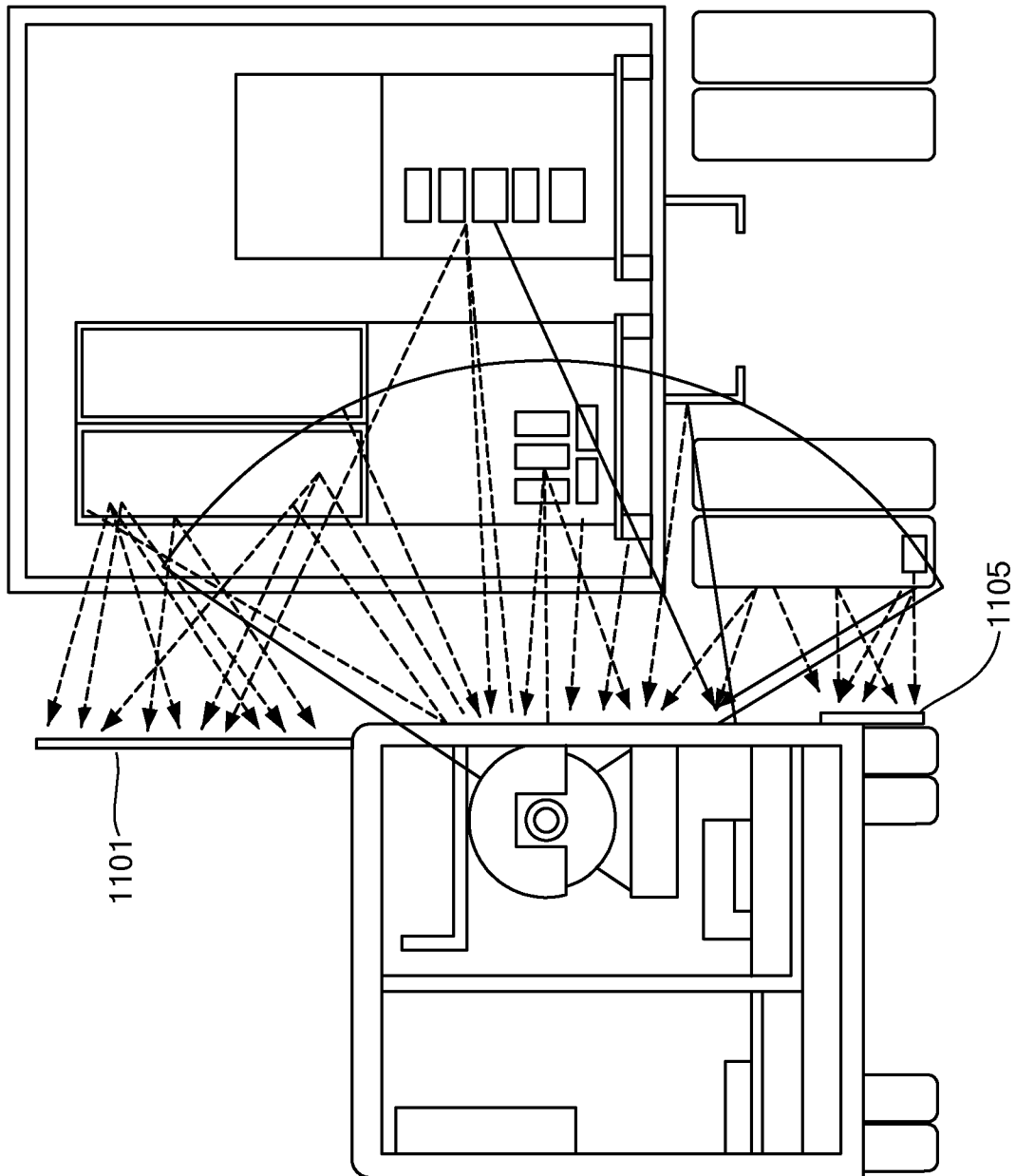
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**FIG. 7****FIG. 8**

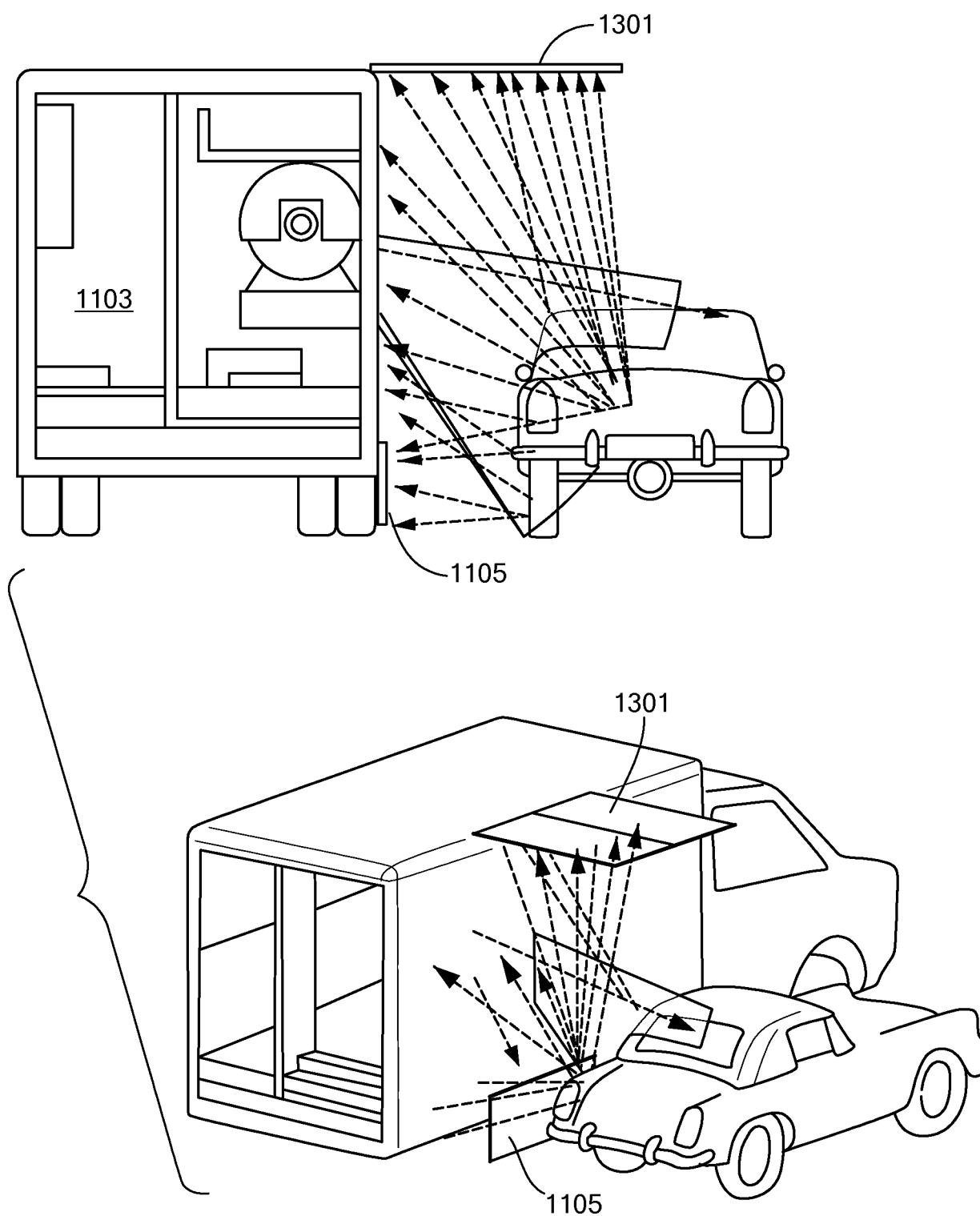
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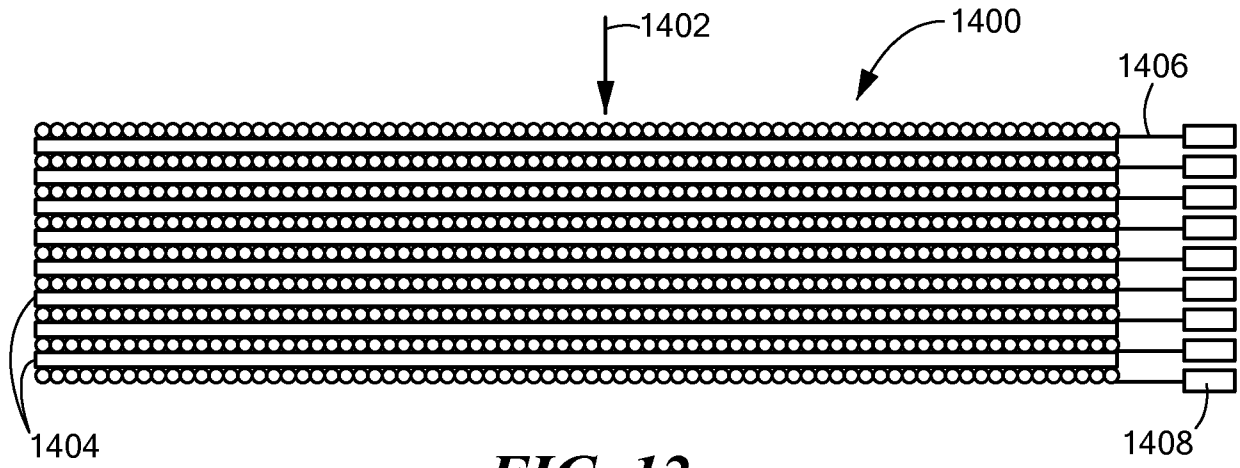
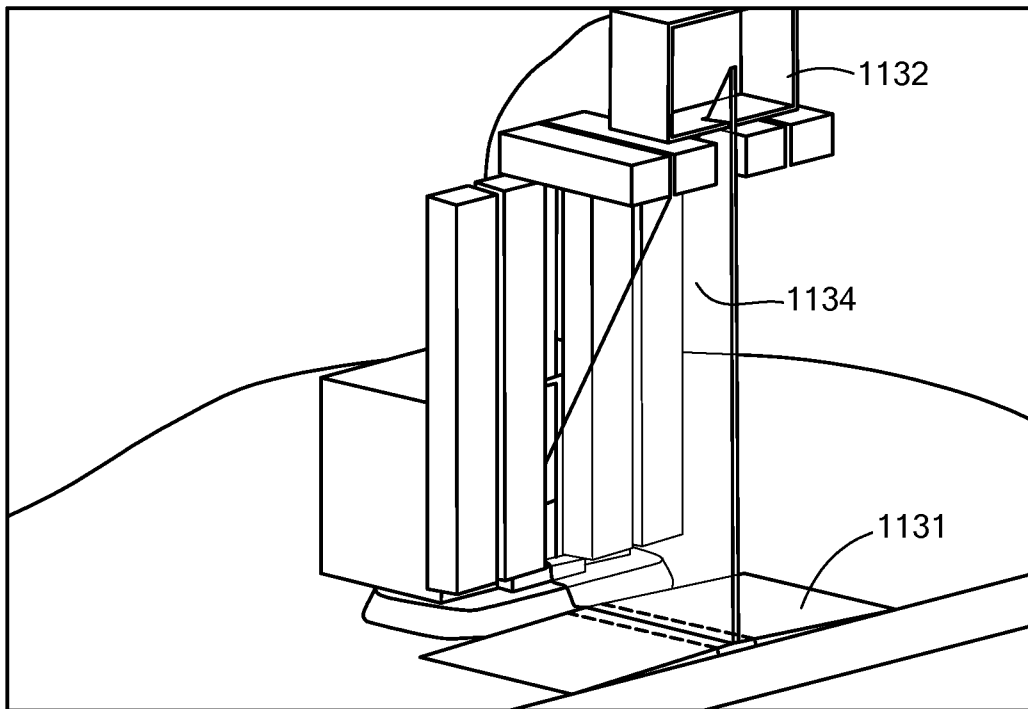
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**FIG. 10**

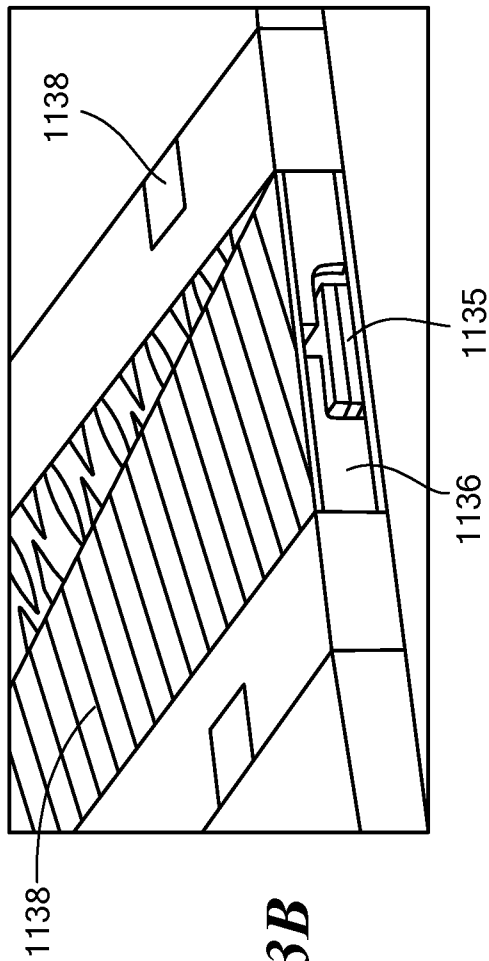
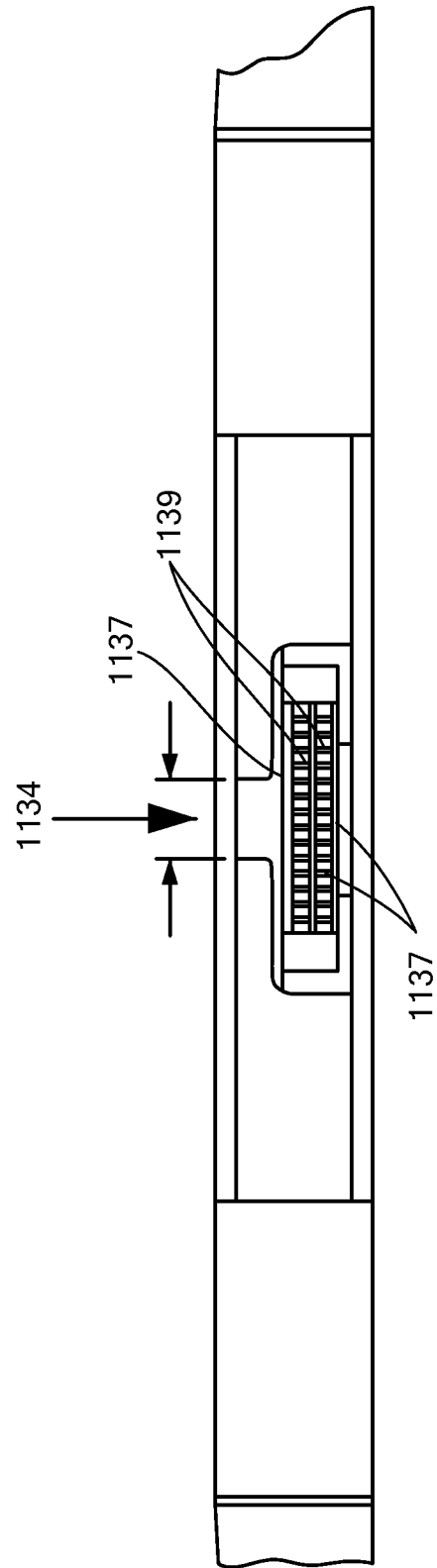
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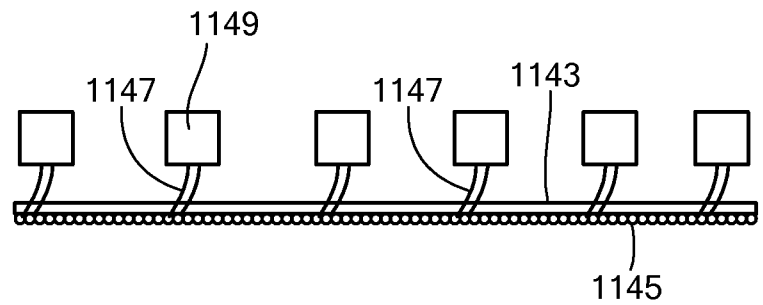
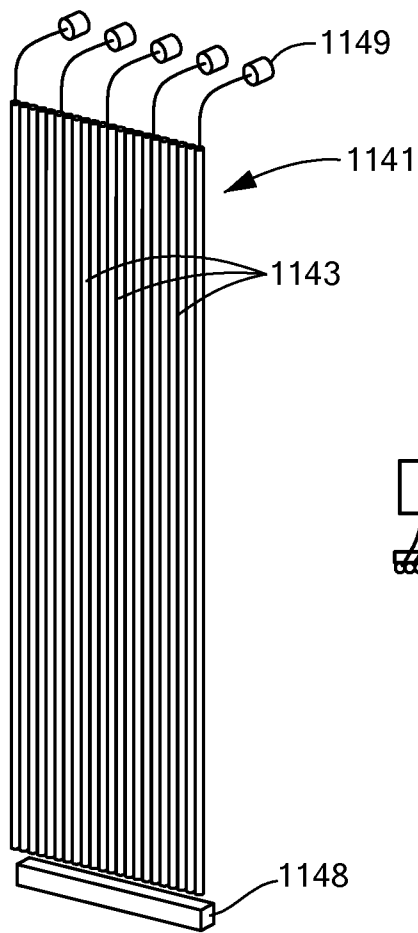
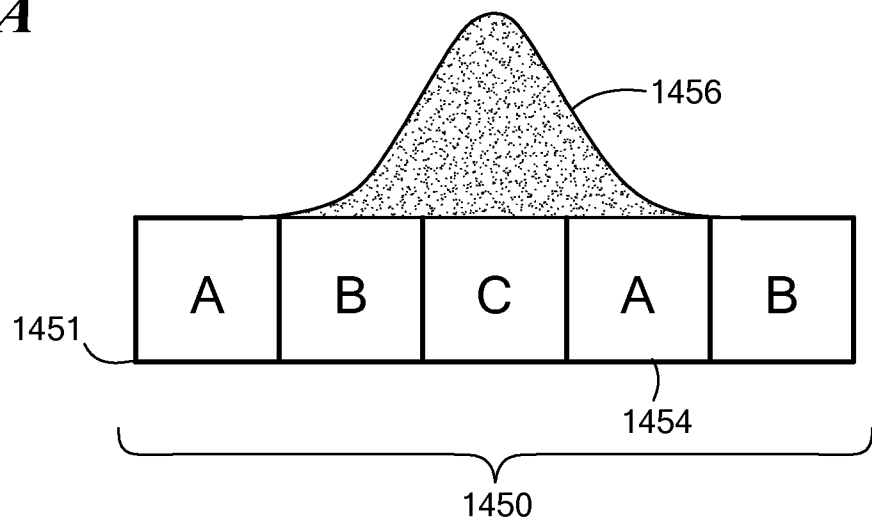
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**FIG. 12****FIG. 13A**

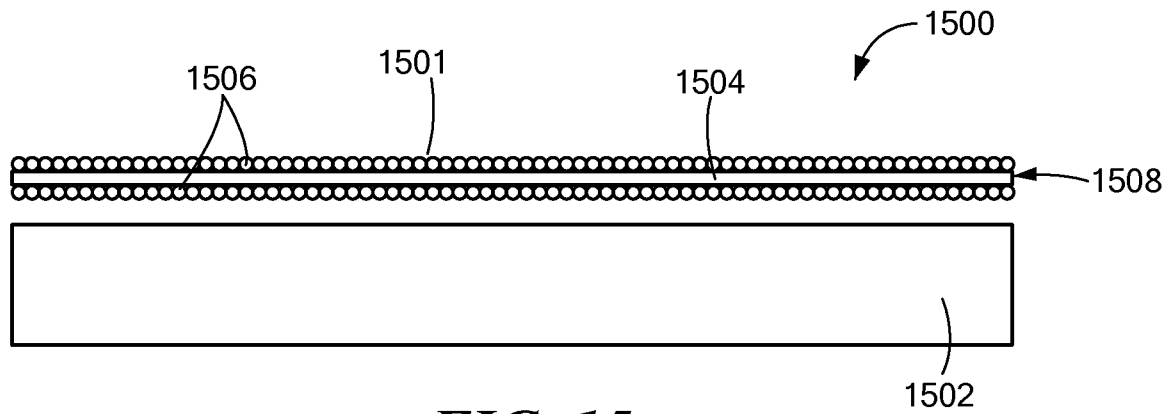
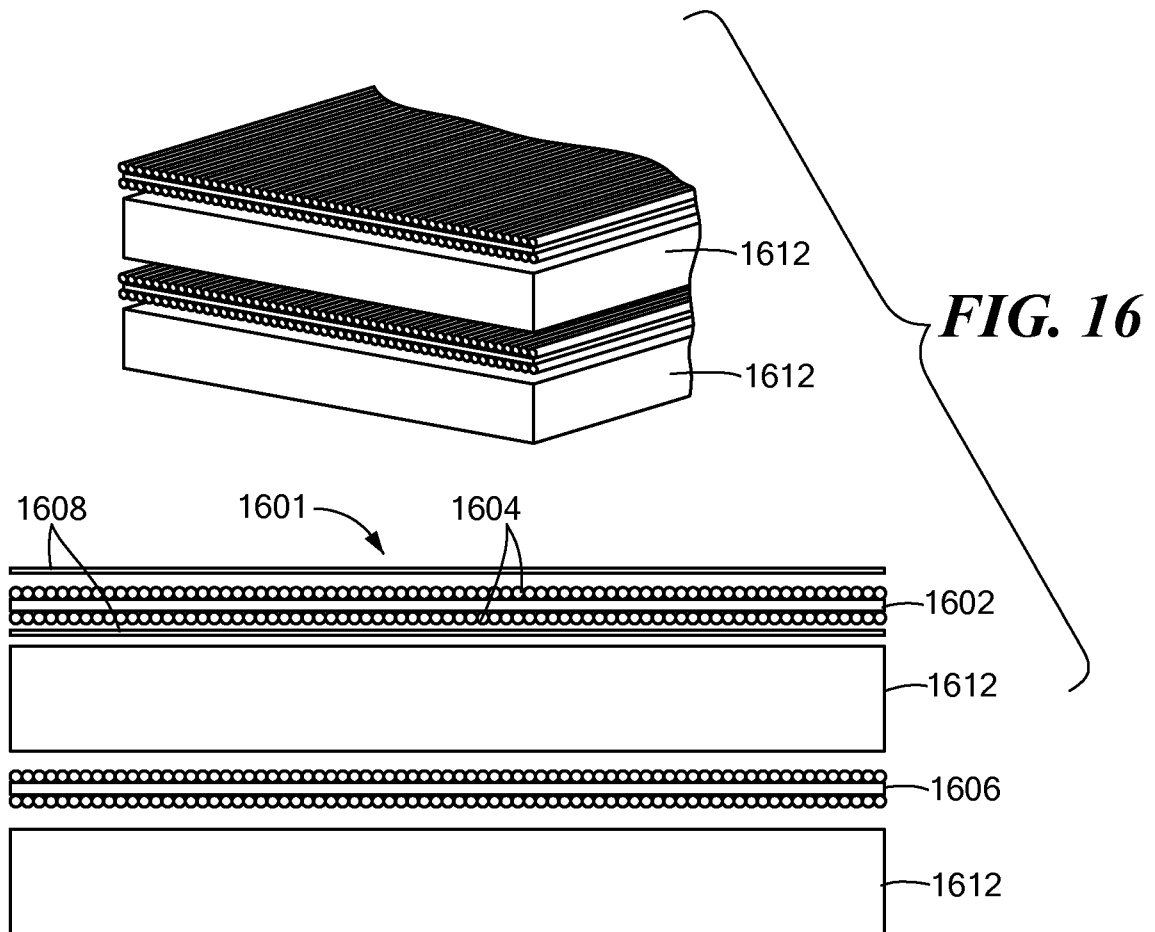
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**FIG. 13B****FIG. 13C**

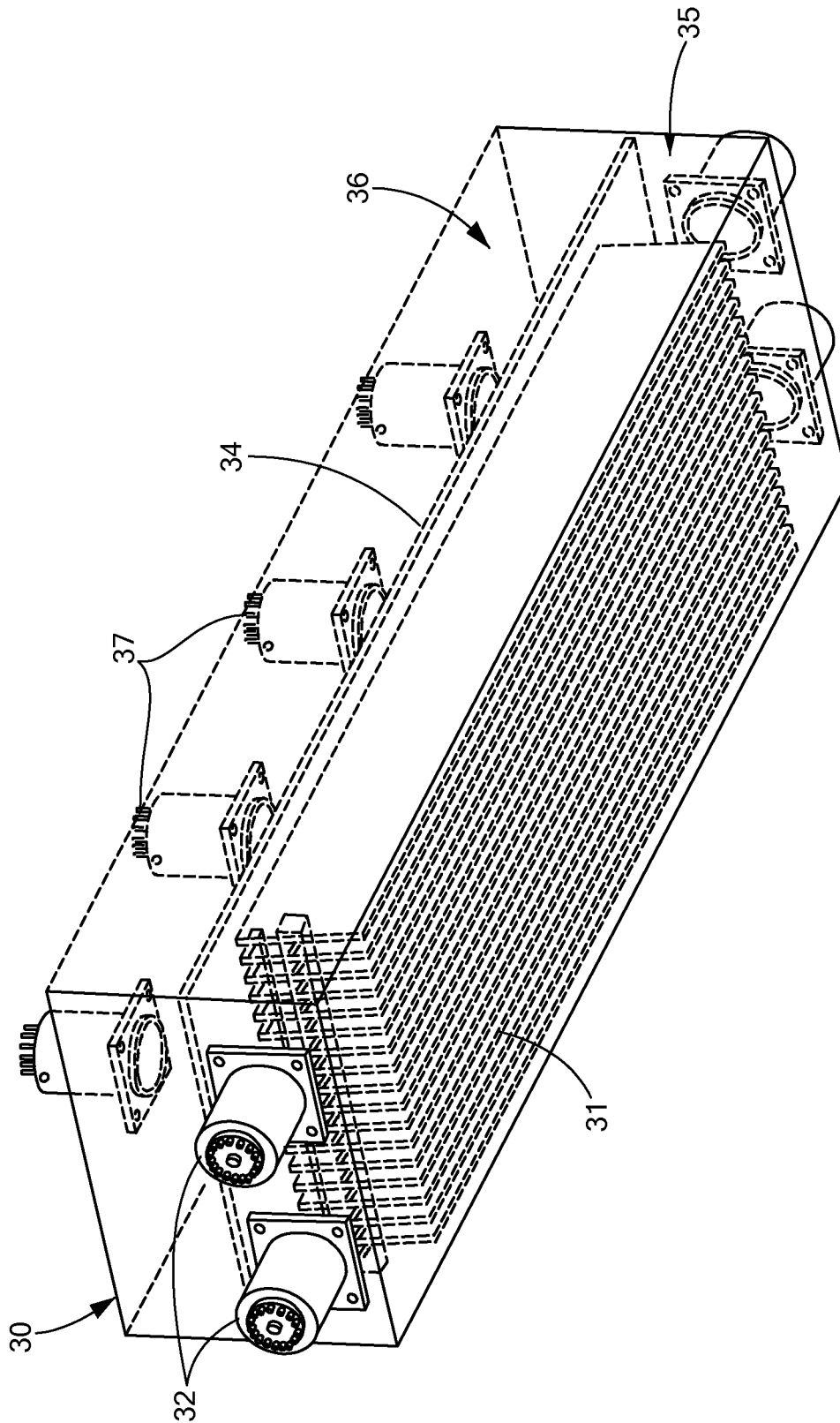
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**FIG. 14B****FIG. 14A****FIG. 14C**

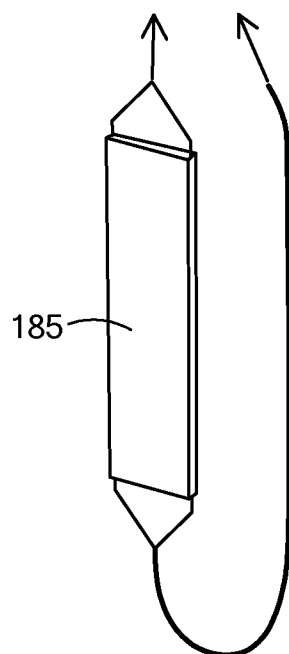
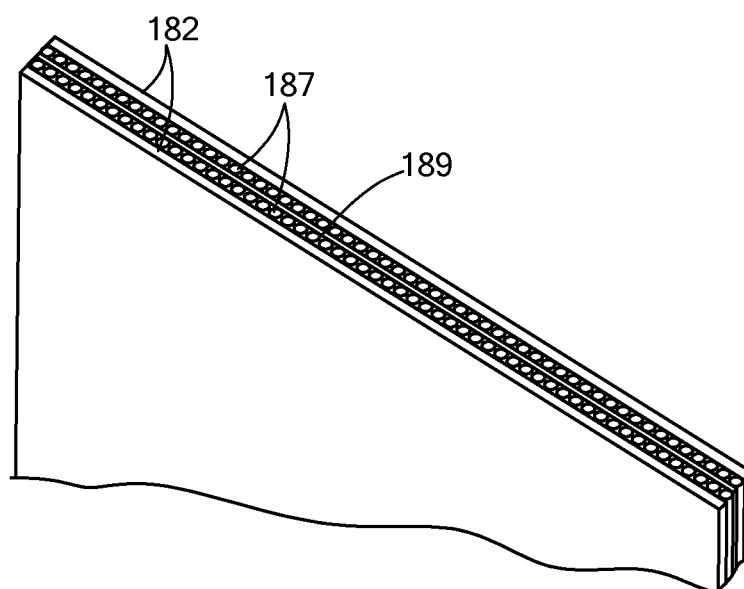
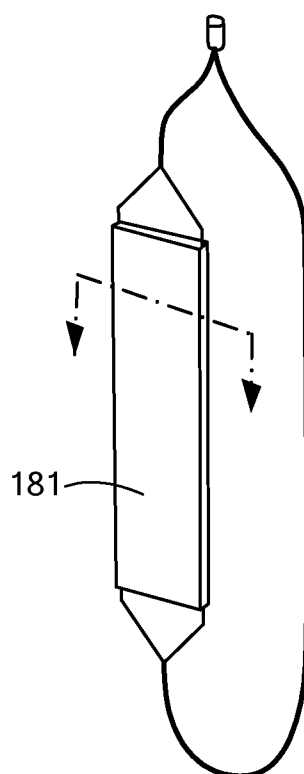
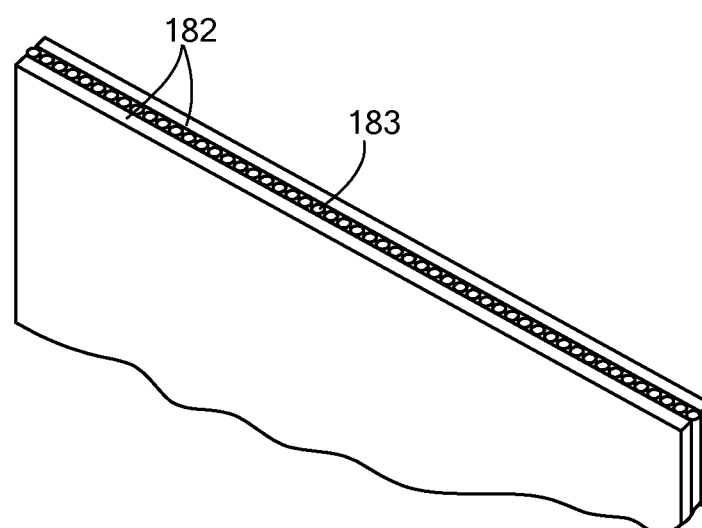
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**FIG. 15**

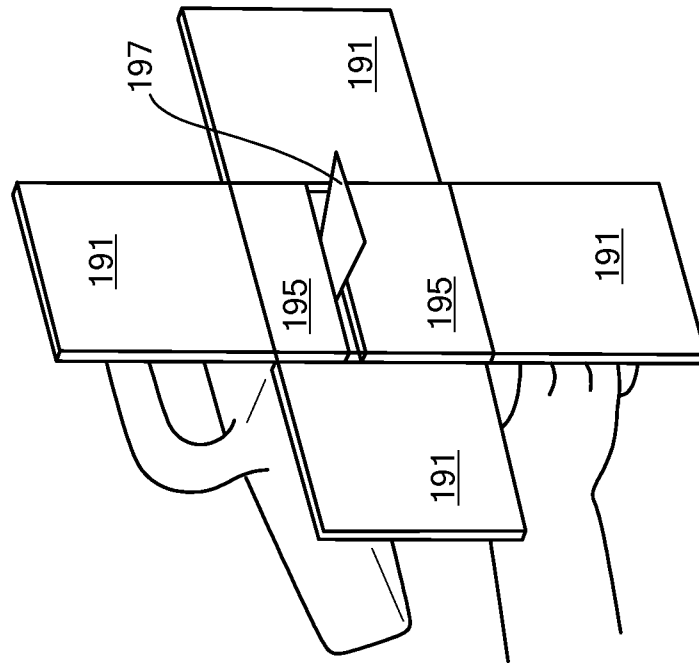
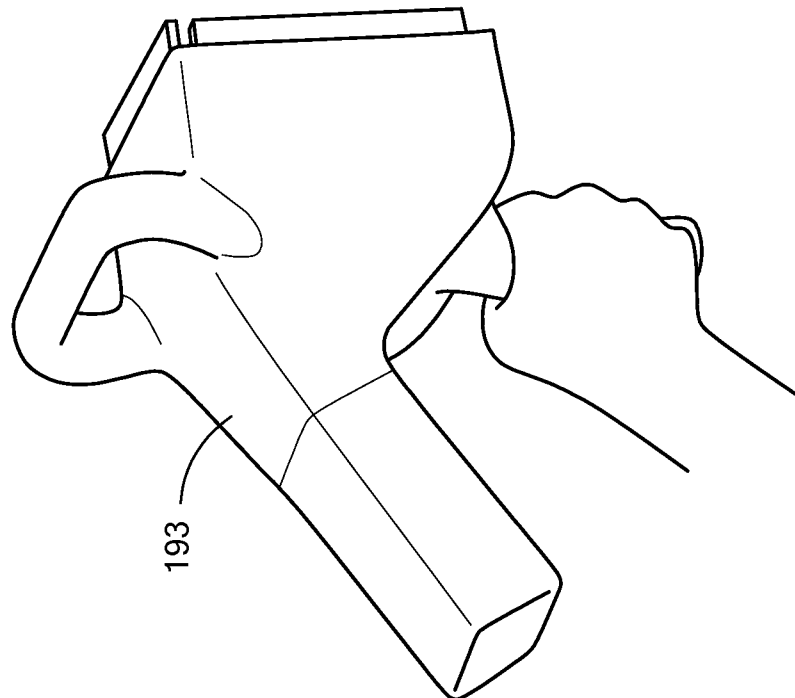
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**FIG. 17**

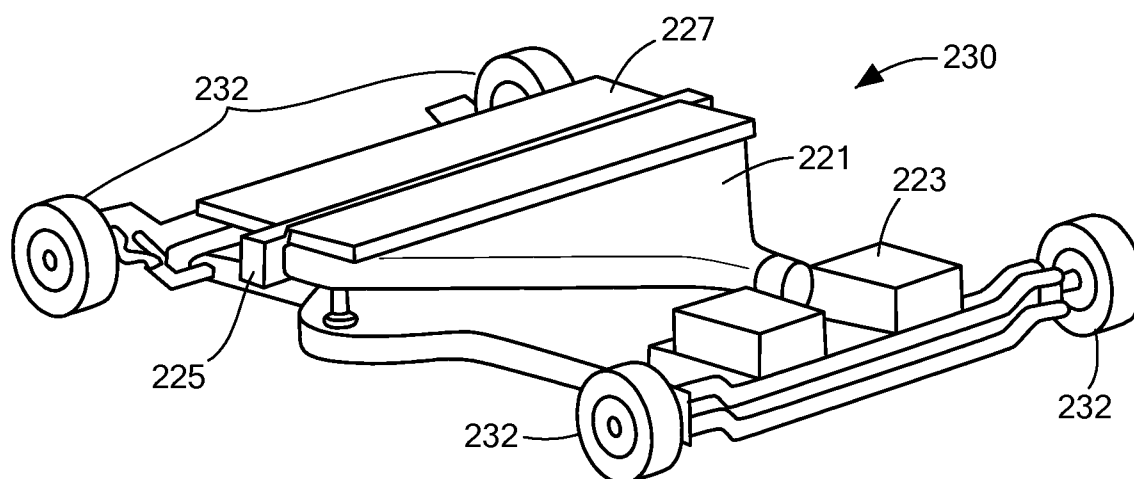
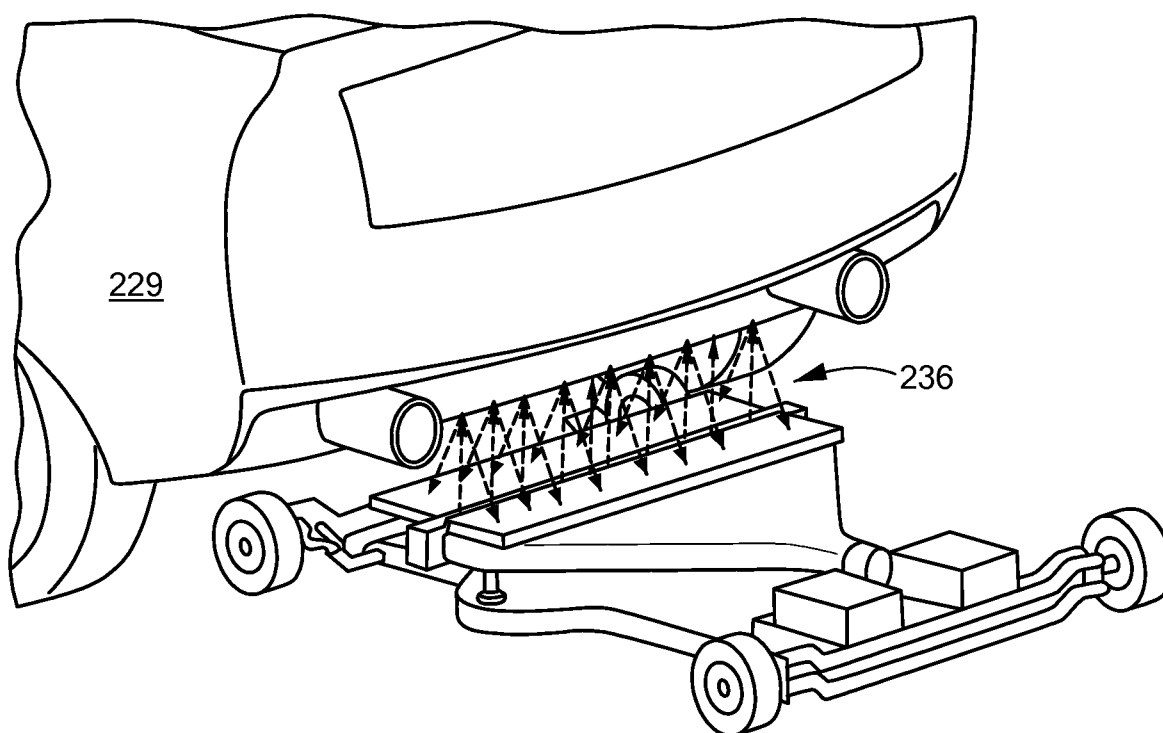
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**FIG. 18A****FIG. 18B****FIG. 18C****FIG. 18D**

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**FIG. 19B****FIG. 19A**

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**FIG. 20A****FIG. 20B**

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